

A Linear-Time Kernel Goodness-of-Fit Test

Wittawat Jitkrittum^{1,*}

NIPS 2017

Best paper!



Kenji Fukumizu³



Wenkai Xu¹

Arthur Gretton¹



Zoltán Szabó²



wittawatj@gmail.com

¹Gatsby Unit, University College London

^{*}(Now at Max Planck Institute for Intelligent Systems)

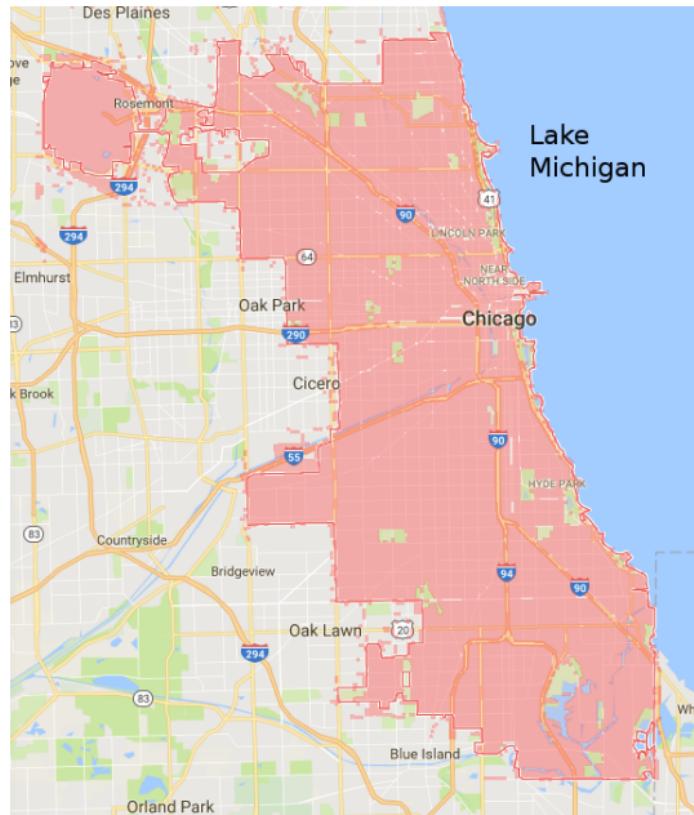
²CMAP, École Polytechnique

³The Institute of Statistical Mathematics, Tokyo

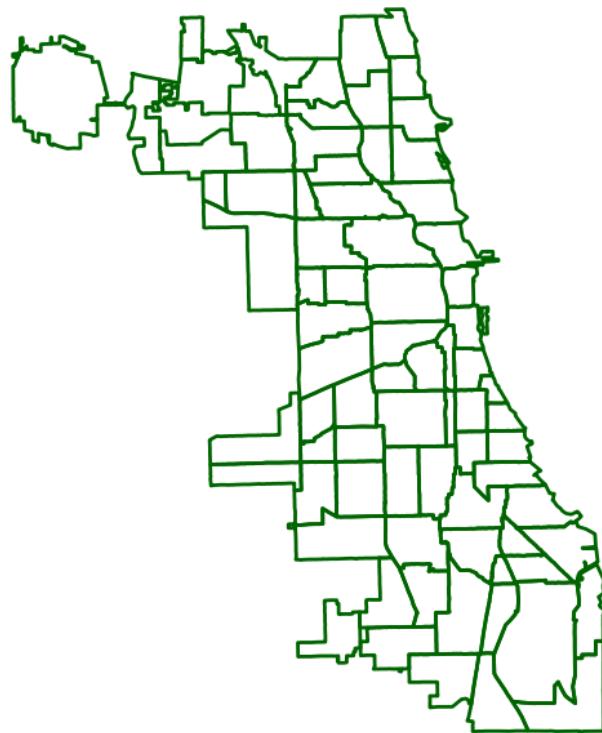
Workshop on Functional Inference and Machine Intelligence, Tokyo

20 February 2018

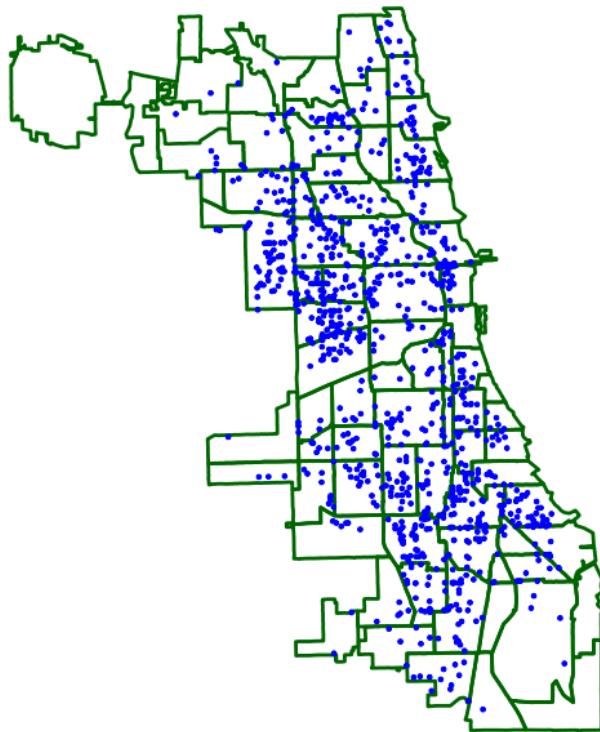
Model Criticism



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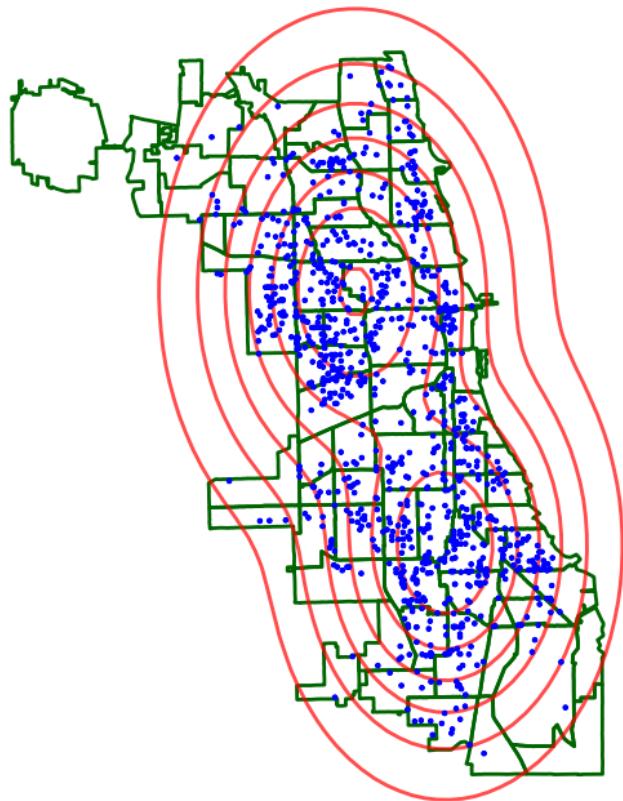


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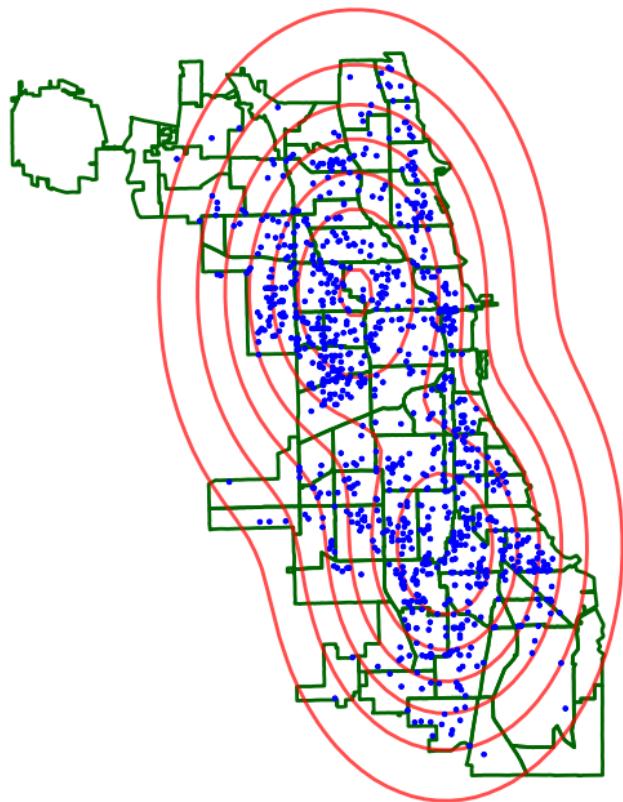
Data = robbery events in Chicago in 2016.

Model Criticism



Is this a good **model**?

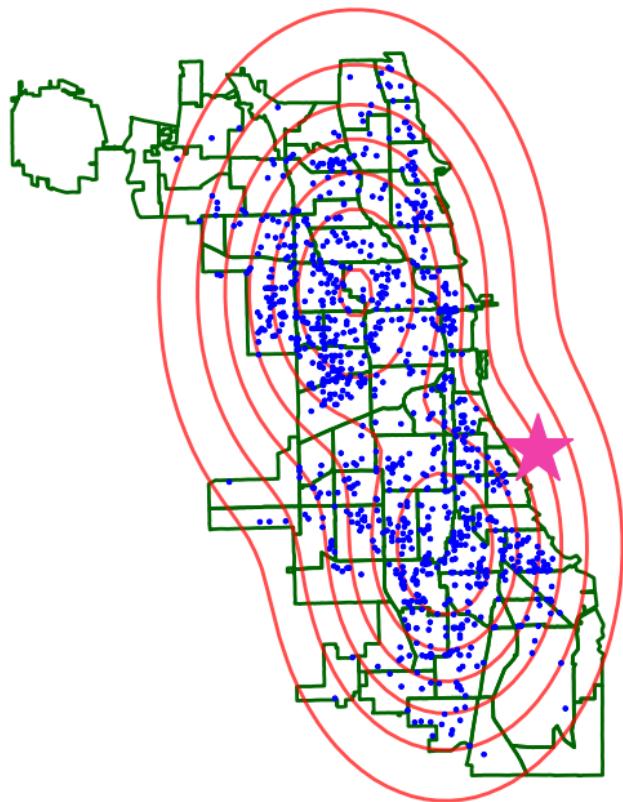
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Goals:

- 1 Test if a (complicated) **model** fits the **data**.
- 2 If it does not, show a **location** where it fails.

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Goodness-of-fit Testing

Given:

- 1 Sample $\{\mathbf{x}_i\}_{i=1}^n \stackrel{i.i.d.}{\sim} q$ (unknown) on \mathbb{R}^d ,
- 2 Unnormalized density p (known model).

$$H_0: p = q$$

$$H_1: p \neq q$$

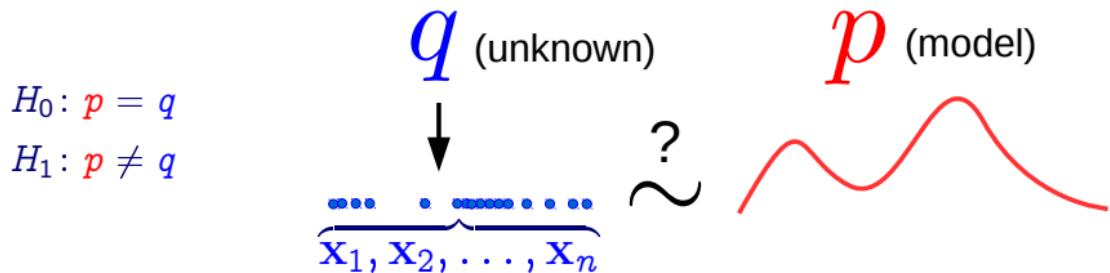
Want a test ...

- 1 Nonparametric.
- 2 Linear-time. Runtime is $\mathcal{O}(n)$. Fast.
- 3 Interpretable. Model criticism by finding .

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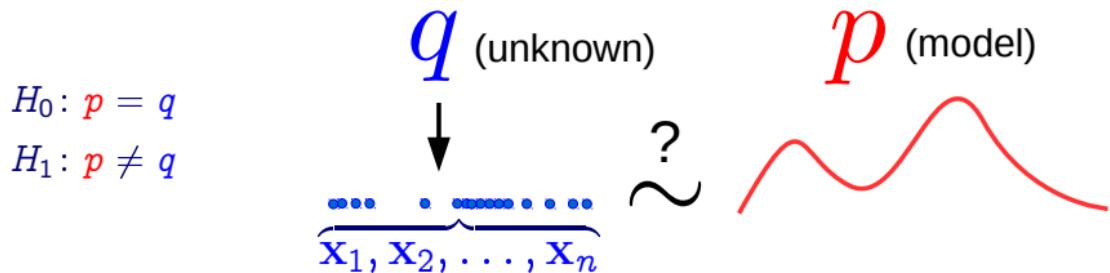
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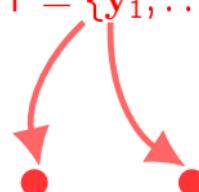
Maximum Mean Discrepancy (MMD) Witness Function (Gretton et al., 2012)

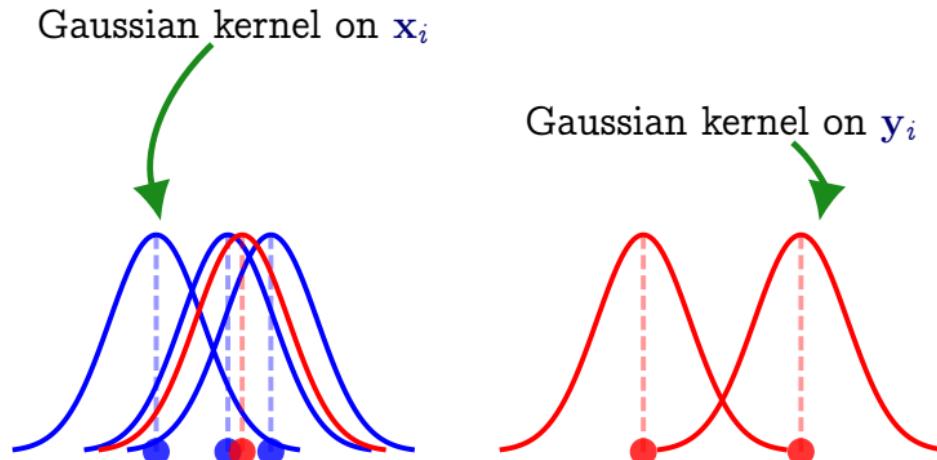


Observe $X = \{x_1, \dots, x_n\} \sim q$

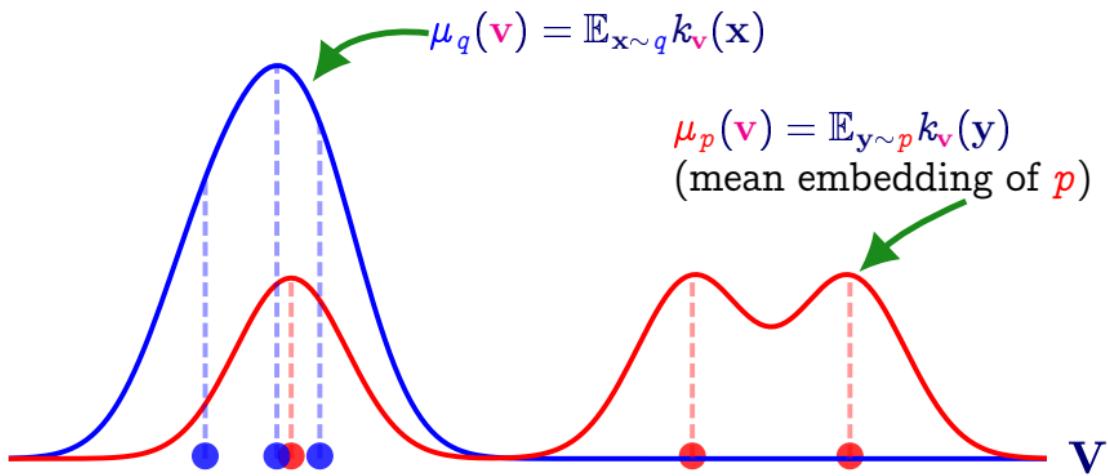


Observe $Y = \{y_1, \dots, y_n\} \sim p$

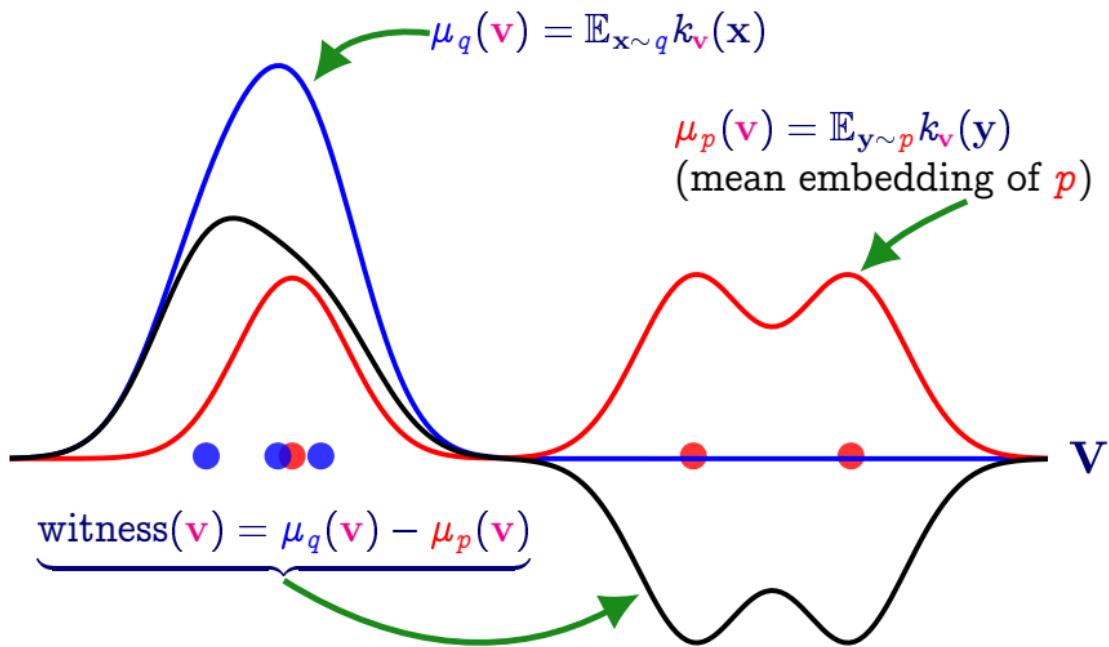




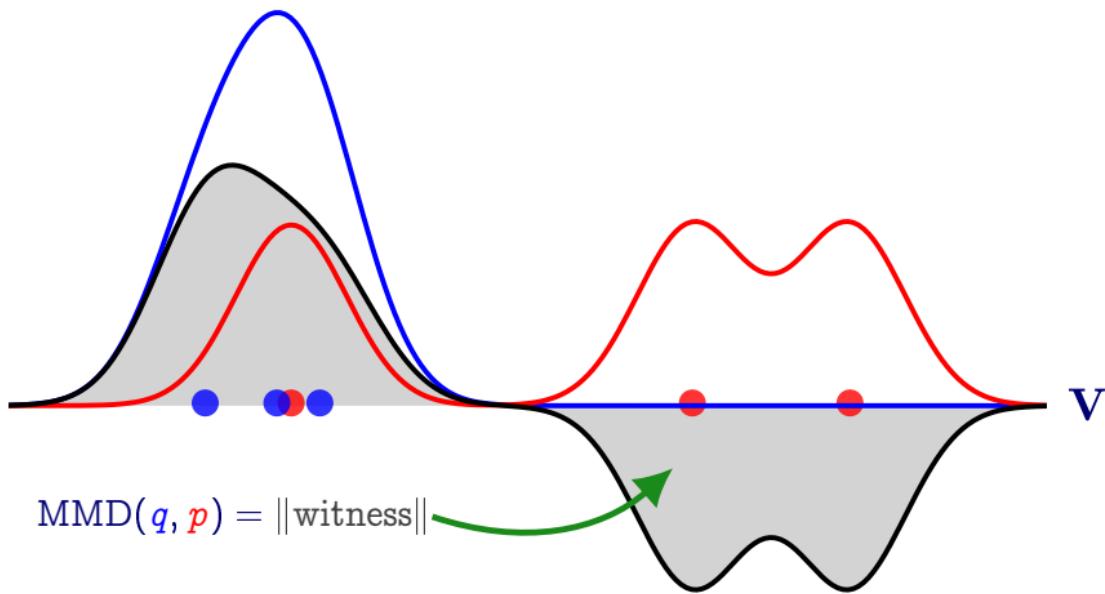
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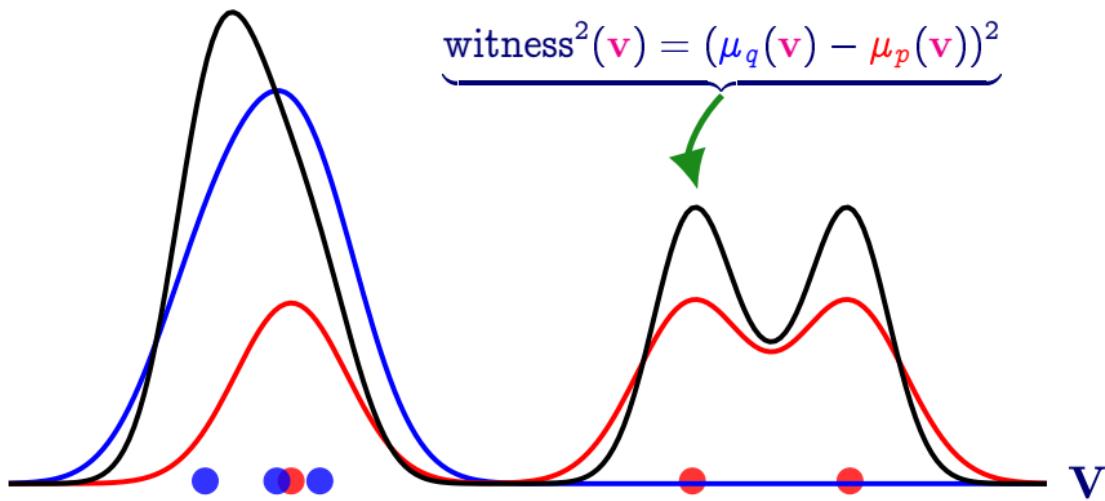
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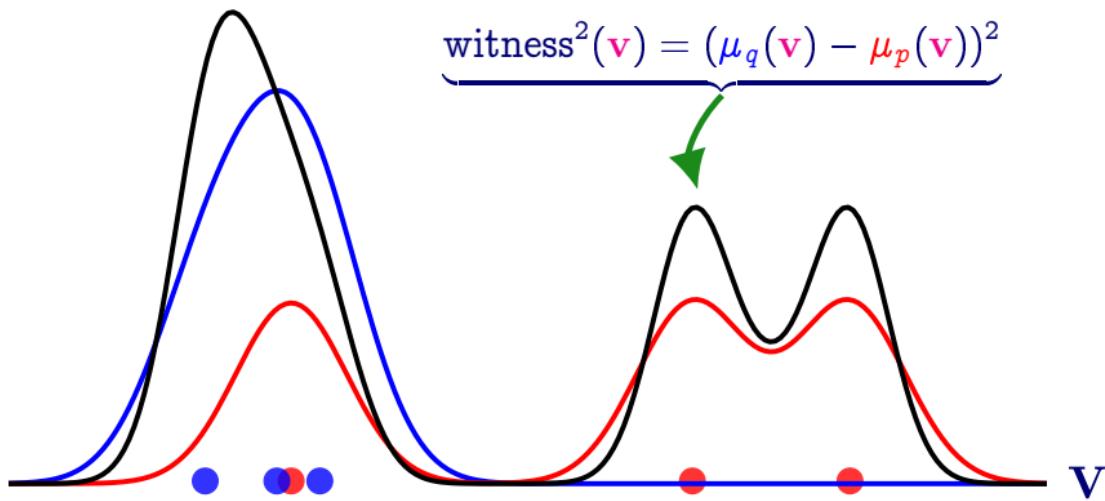
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- $\text{witness}^2(\mathbf{v})$ can be used to find a good test location $\mathbf{v}^* = \star$.

Model Criticism by the MMD Witness

- Find a location \mathbf{v} at which q and p differ most (ME test)
[Jitkrittum et al., 2016].

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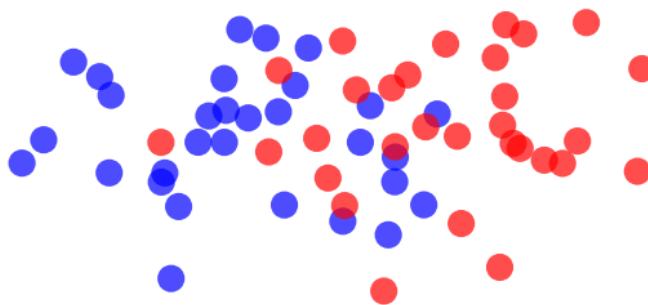
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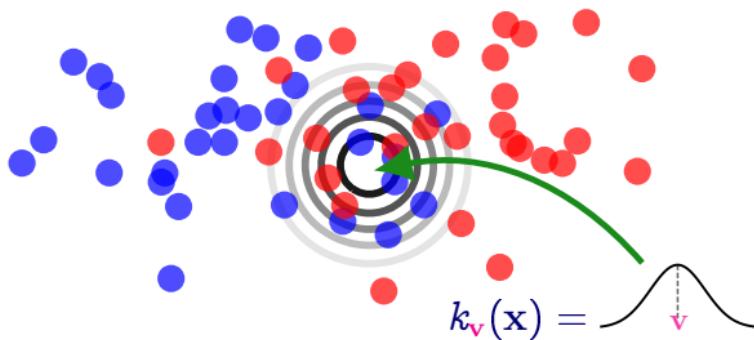


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score: 0.008

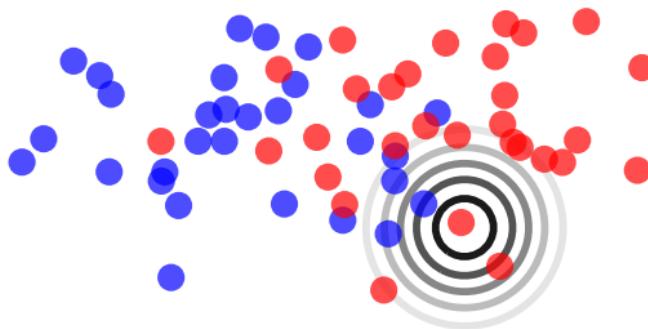


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score: 1.6

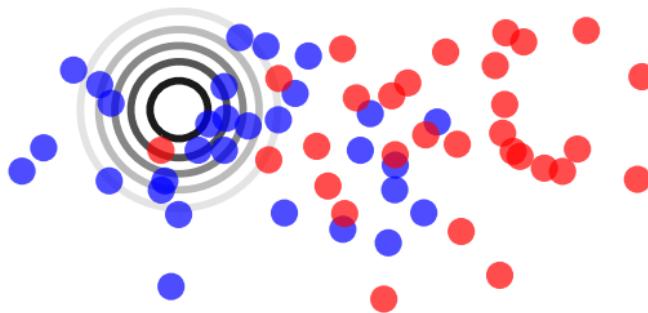


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score: 13

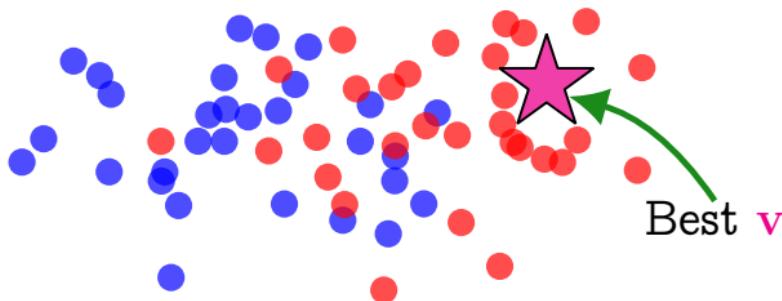


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score: 25

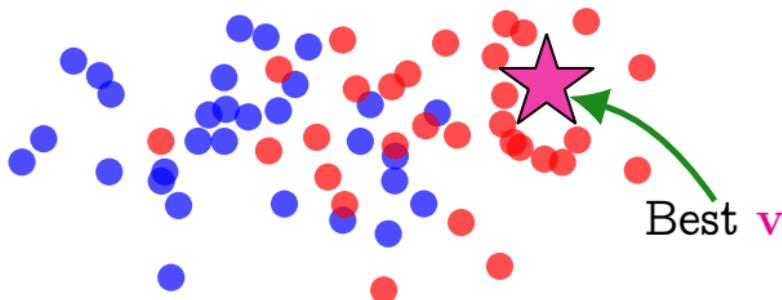


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No sample from p .
Difficult to generate.

The Stein Witness Function [Liu et al., 2016, Chwialkowski et al., 2016]

Problem: No sample from p . Cannot estimate $\mathbb{E}_{\mathbf{y} \sim p}[k_{\mathbf{v}}(\mathbf{y})]$.

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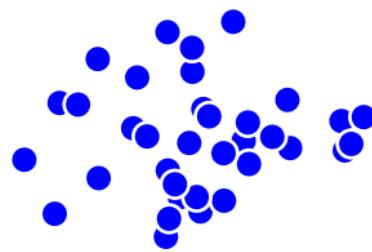
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Goodness-of-fit test:

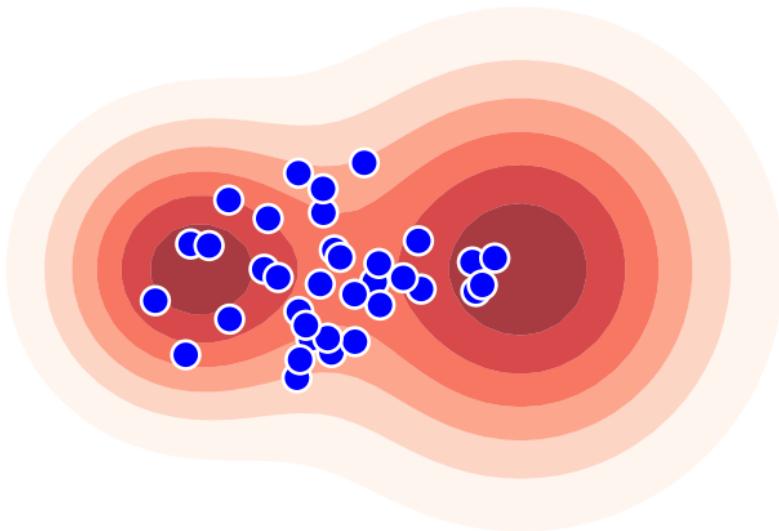
- 1 Find $\mathbf{v}^* = \arg \max_{\mathbf{v}} \text{score}(\mathbf{v})$.
- 2 Reject H_0 if $\text{witness}^2(\mathbf{v}^*) > \text{threshold}$.

Proposal: Model Criticism with the Stein Witness



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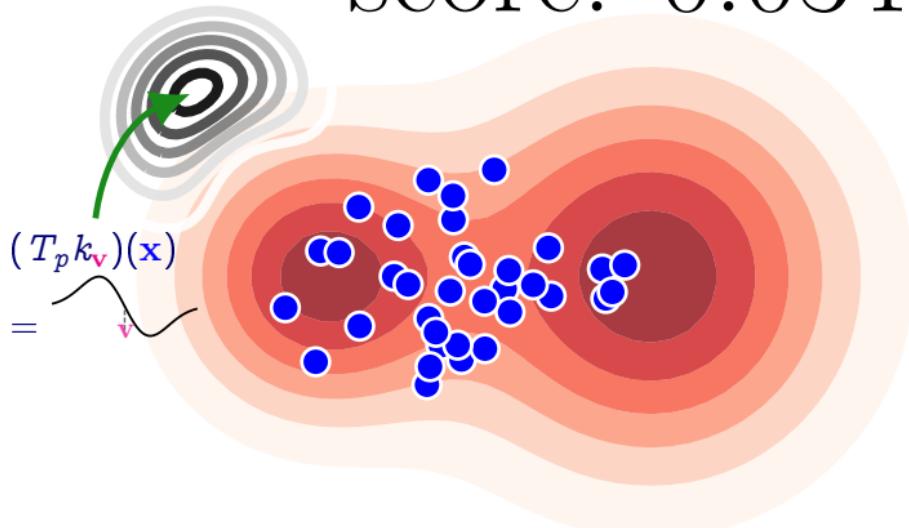
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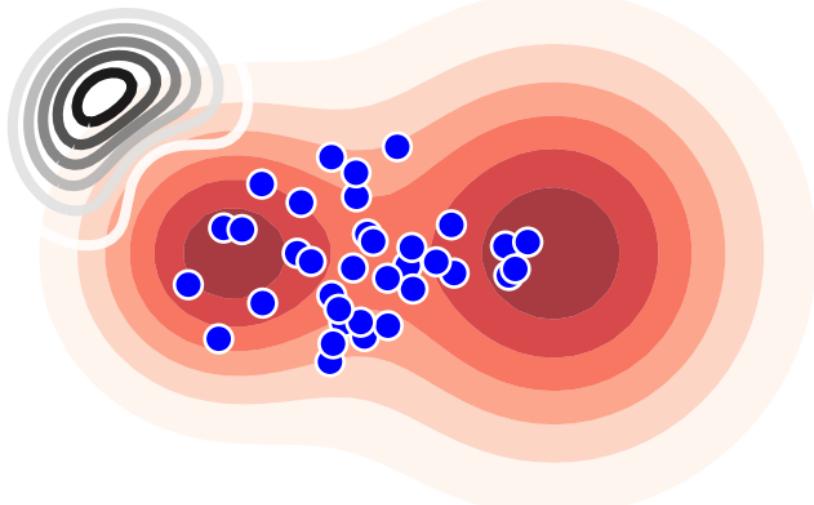
score: 0.034



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Proposal: Model Criticism with the Stein Witness

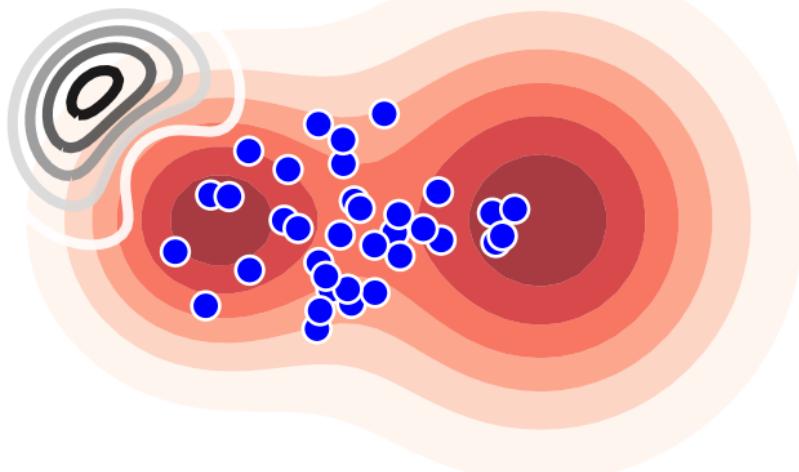
score: 0.089



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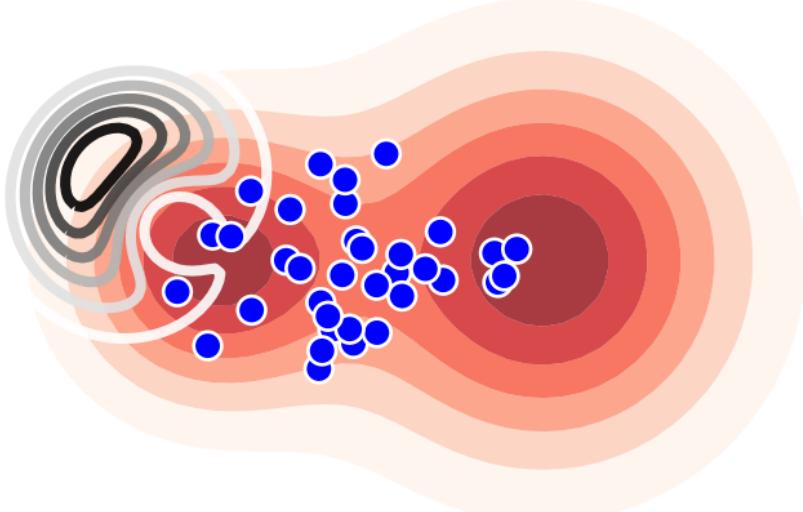
score: 0.17



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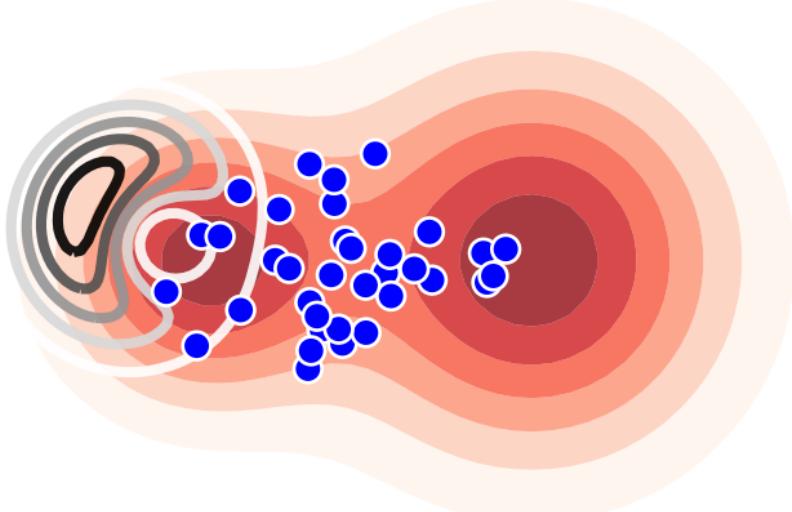
score: 0.26



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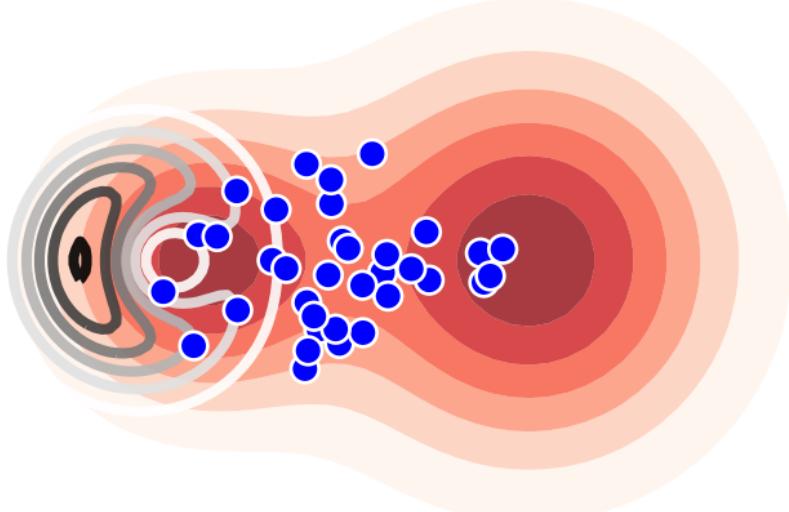
score: 0.33



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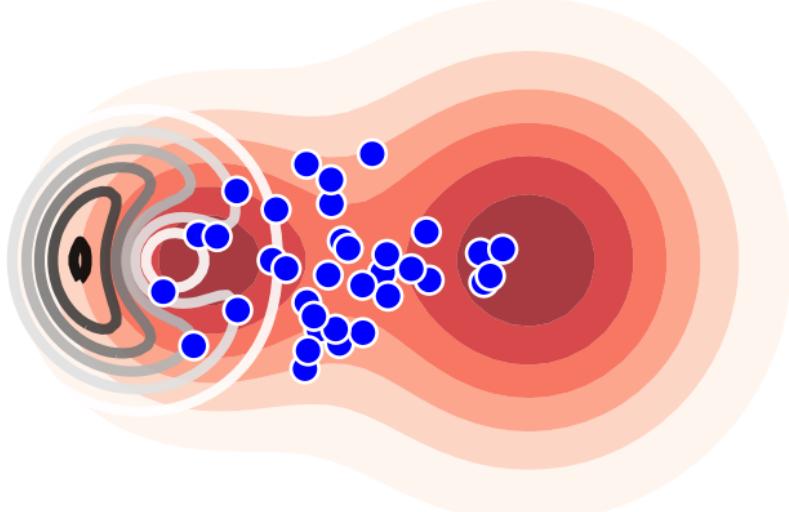
score: 0.37



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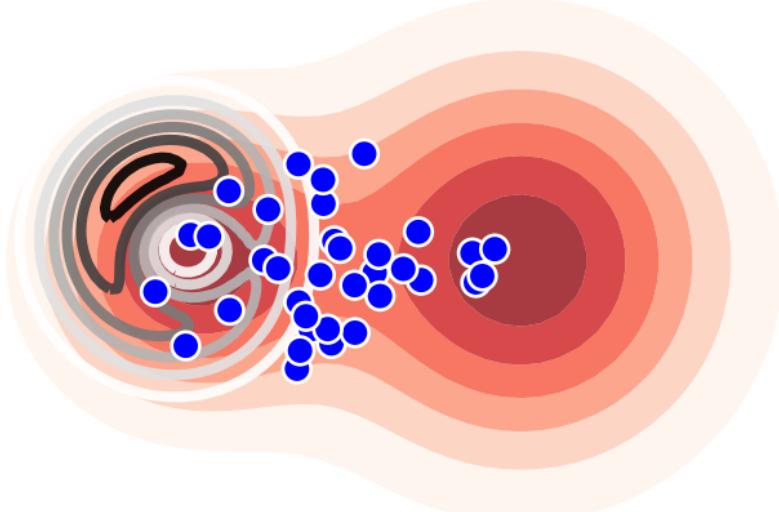
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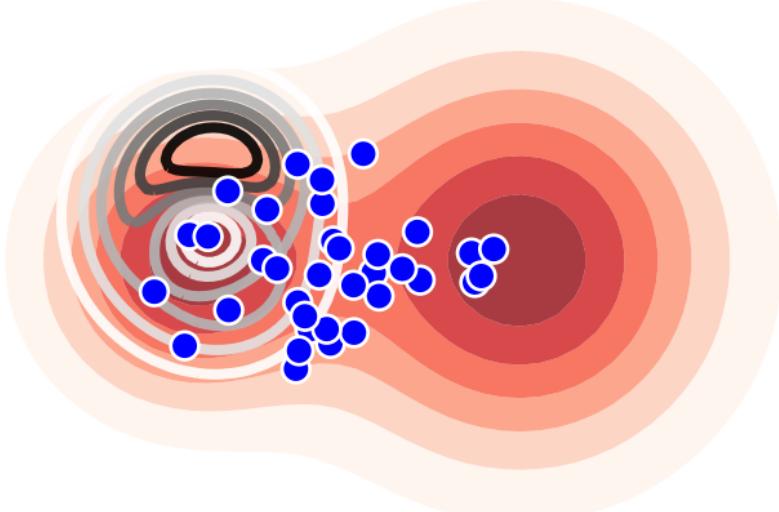
score: 0.45



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Proposal: Model Criticism with the Stein Witness

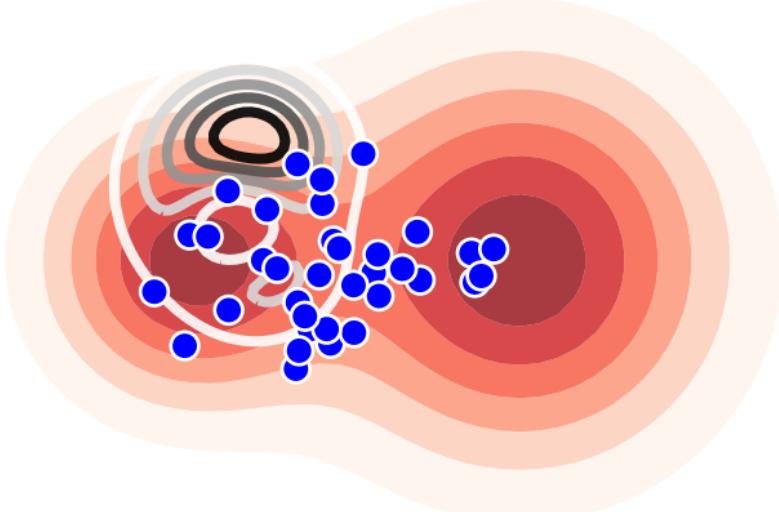
score: 0.44



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Proposal: Model Criticism with the Stein Witness

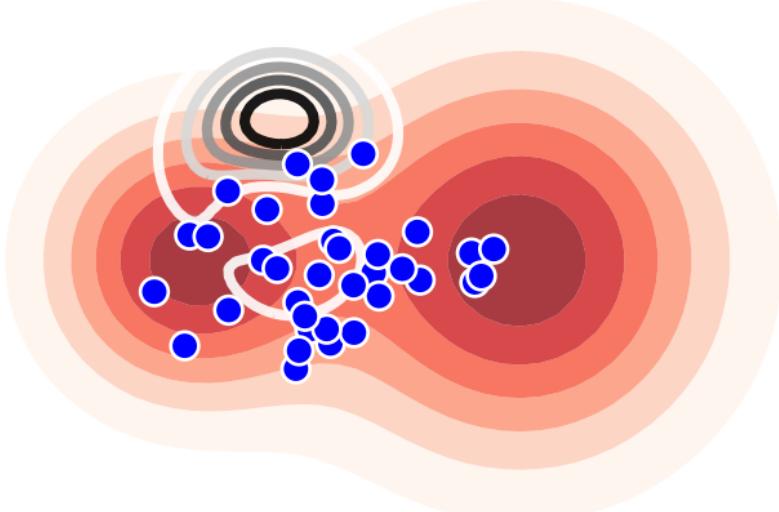
score: 0.39



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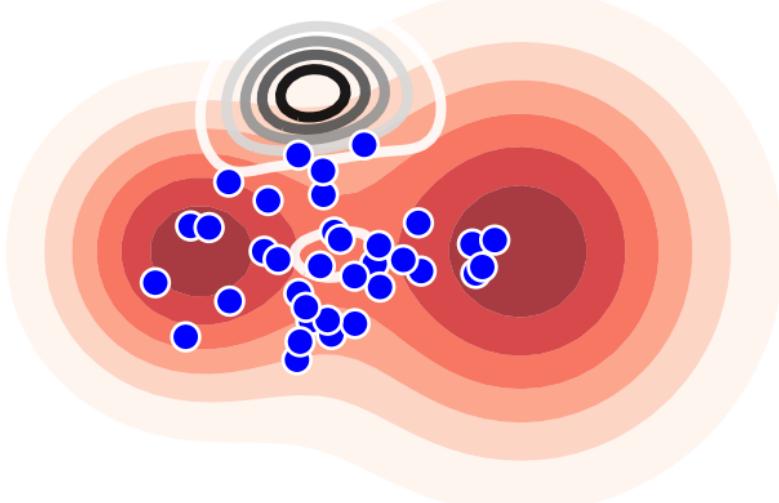
score: 0.31



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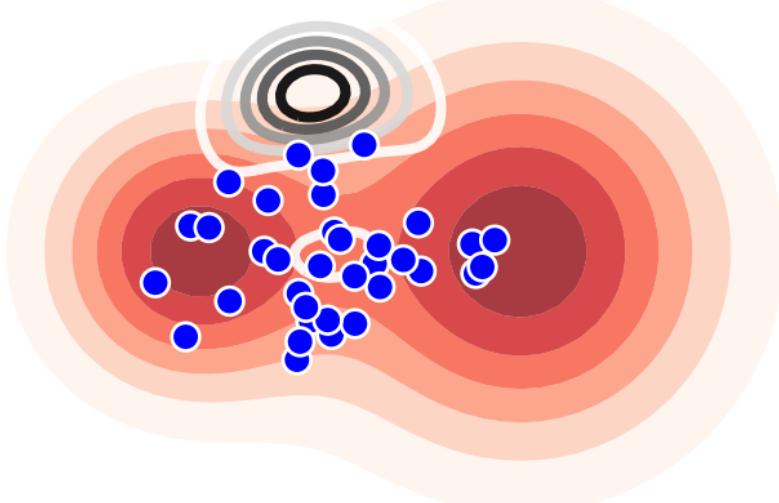
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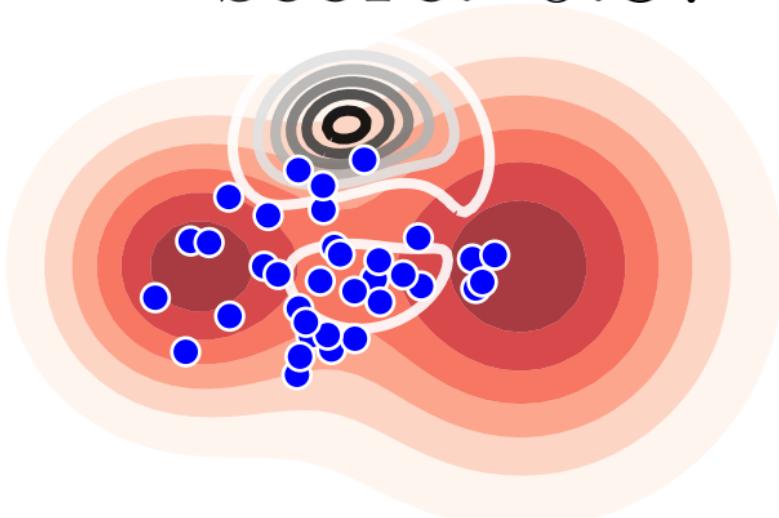
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Proposal: Model Criticism with the Stein Witness

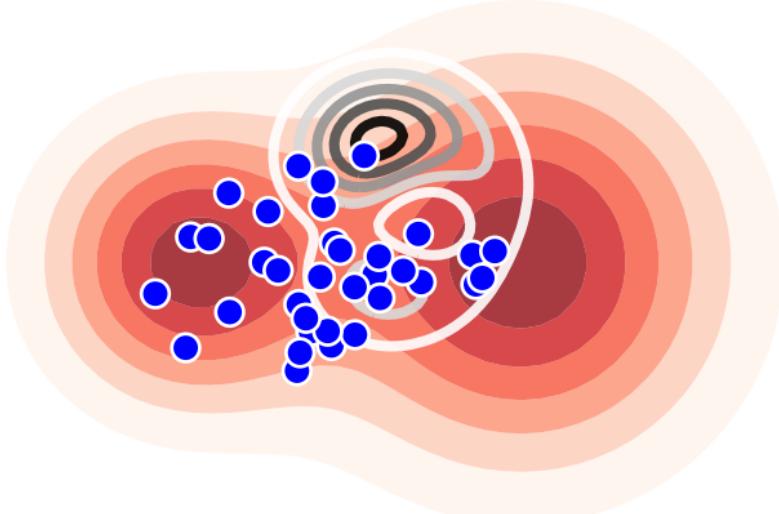
score: 0.37



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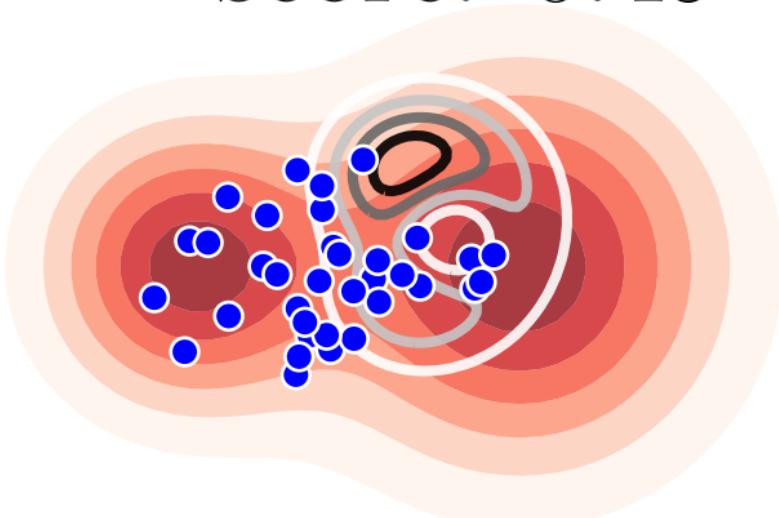
score: 0.48



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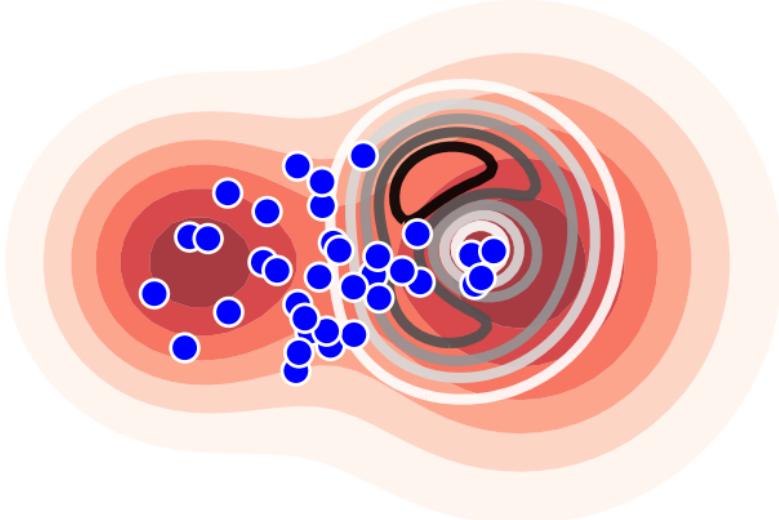
score: 0.49



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Proposal: Model Criticism with the Stein Witness

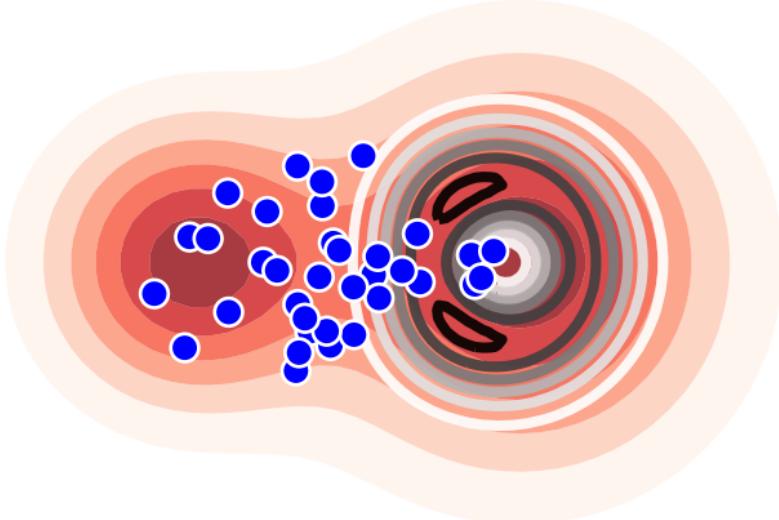
score: 0.47



$$\text{score}(\mathbf{v}) = \frac{\text{witness}^2(\mathbf{v})}{\text{noise}(\mathbf{v})}.$$

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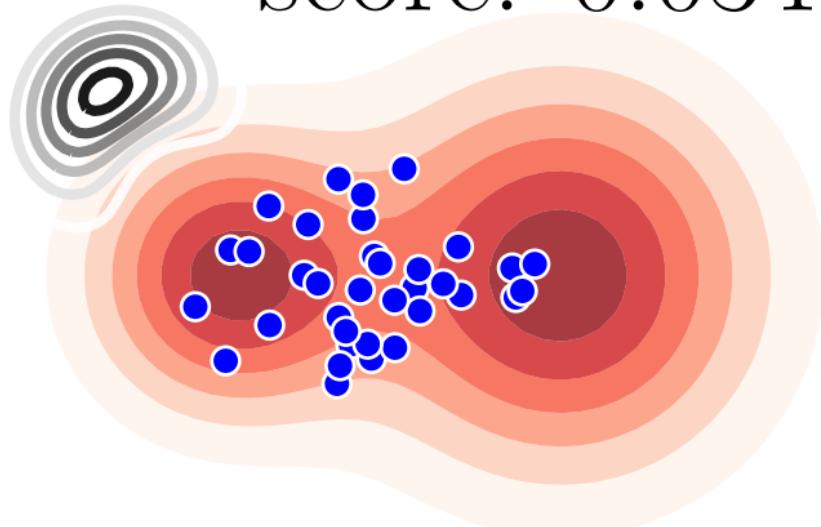
score: 0.44



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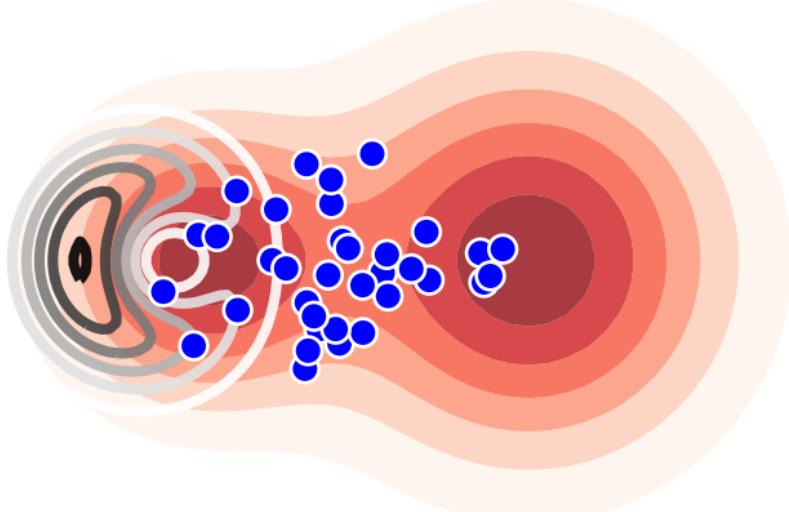
score: 0.034



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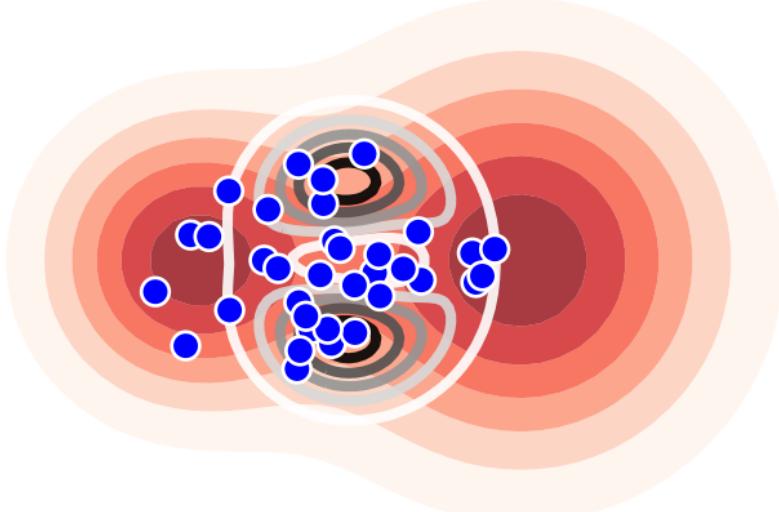
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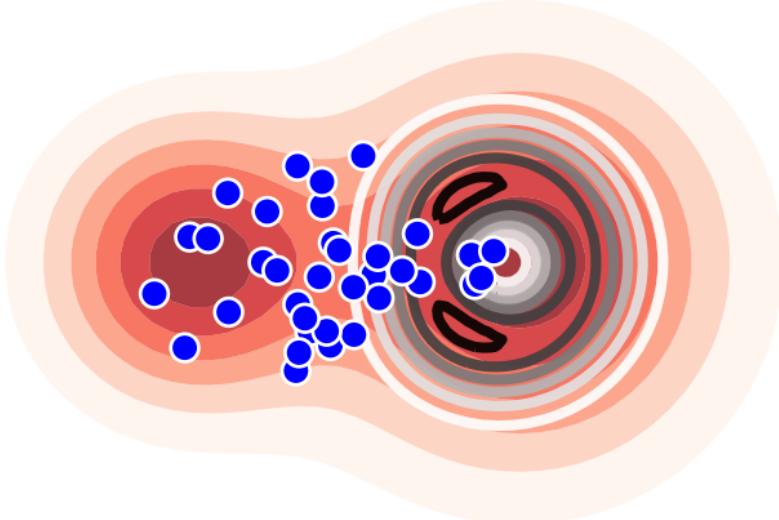
score: 0.16



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Proposal: Model Criticism with the Stein Witness

score: 0.44



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Theory

- 1 What is $T_p k_v$?
- 2 Test statistic
- 3 Distributions of the test statistic, test threshold.
- 4 What does $v^* = \arg \max_v \text{score}(v)$ do theoretically?

(1) What is $T_p k_v$?

Recall $\text{witness}(\mathbf{v}) = \mathbb{E}_{\mathbf{x} \sim q}(T_p k_{\mathbf{v}})(\mathbf{x}) - \mathbb{E}_{\mathbf{y} \sim p}(\overline{T_p k_{\mathbf{v}}}(\mathbf{y}))$

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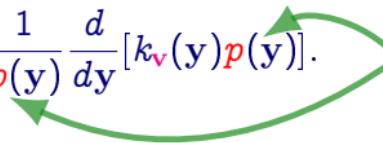
$$(T_p k_{\mathbf{v}})(\mathbf{y}) = \frac{1}{p(\mathbf{y})} \frac{d}{d\mathbf{y}} [k_{\mathbf{v}}(\mathbf{y}) p(\mathbf{y})].$$

Then, $\mathbb{E}_{\mathbf{y} \sim p}(T_p k_{\mathbf{v}})(\mathbf{y}) = 0$.

[Liu et al., 2016, Chwialkowski et al., 2016]

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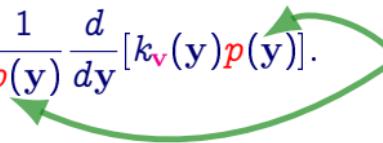
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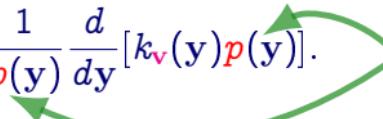
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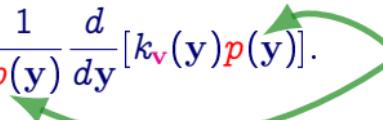
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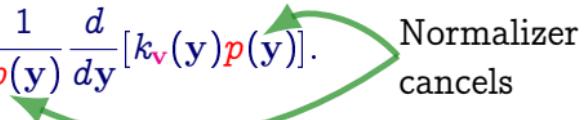
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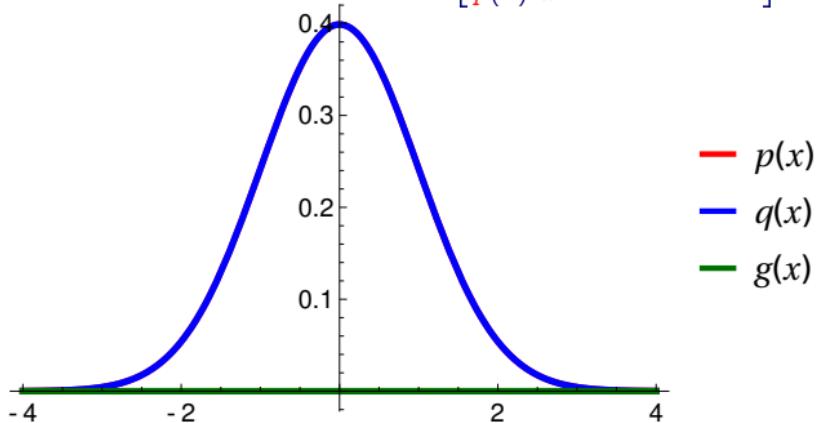
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(assume $\lim_{|y| \rightarrow \infty} k_v(y)p(y) = 0$)

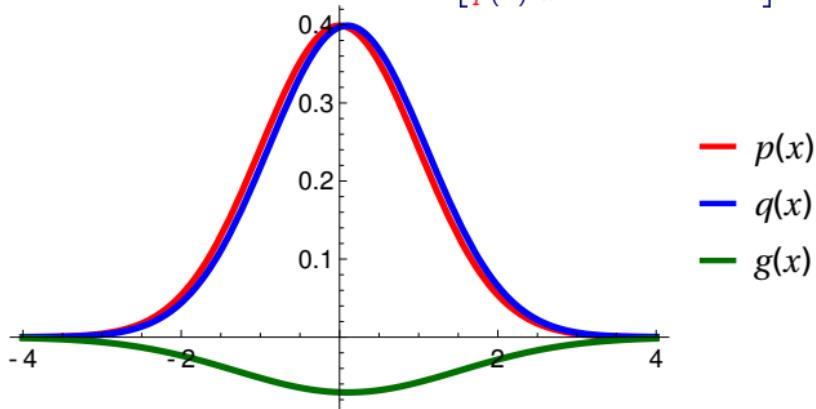
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- Recall Stein witness: $g(\mathbf{v}) := \mathbb{E}_{\mathbf{x} \sim q} \left[\frac{1}{p(\mathbf{x})} \frac{d}{d\mathbf{x}} [k_{\mathbf{v}}(\mathbf{x}) p(\mathbf{x})] \right]$.



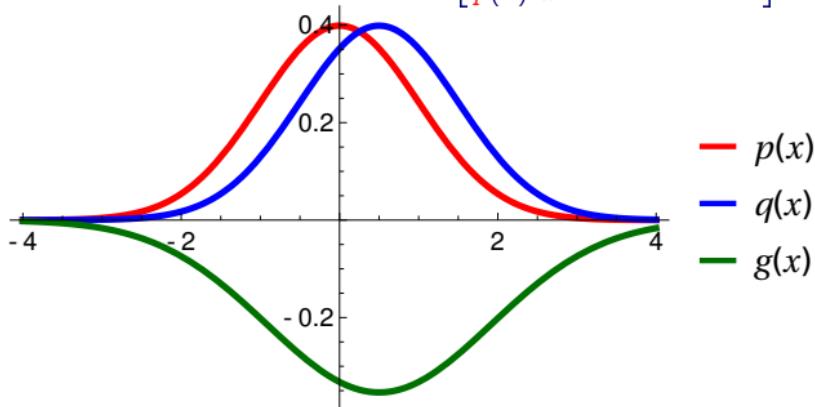
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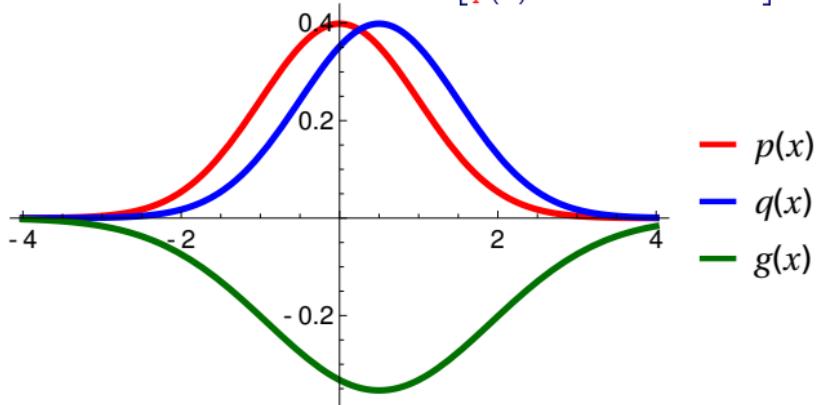
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- FSSD statistic: Evaluate g^2 at J test locations $V = \{\mathbf{v}_1, \dots, \mathbf{v}_J\}$.
- Population FSSD

$$\text{FSSD}^2 = \frac{1}{dJ} \sum_{j=1}^J \|\mathbf{g}(\mathbf{v}_j)\|_2^2.$$

- Unbiased estimator $\widehat{\text{FSSD}}^2$ computable in $\mathcal{O}(d^2 J n)$ time. (d = input dimension)

(2) FSSD is a Discrepancy Measure

■ $\text{FSSD}^2 = \frac{1}{dJ} \sum_{j=1}^J \|\mathbf{g}(\mathbf{v}_j)\|_2^2.$

Theorem 1 (FSSD is a discrepancy measure).

Main conditions:

- 1 (*Nice kernel*) Kernel k is C_0 -universal, and *real analytic* e.g., Gaussian kernel.
- 2 (*Vanishing boundary*) $\lim_{\|\mathbf{x}\| \rightarrow \infty} p(\mathbf{x})k_{\mathbf{v}}(\mathbf{x}) = 0$.
- 3 (*Avoid “blind spots”*) Locations $\mathbf{v}_1, \dots, \mathbf{v}_J \sim \eta$ which has a density.

Then, for any $J \geq 1$, η -almost surely,

$$\text{FSSD}^2 = 0 \iff p = q.$$

Summary: Evaluating the witness at random locations is sufficient to detect the discrepancy between p, q .

(2) What Are “Blind Spots”?

$$\text{Recall } g(\mathbf{v}) := \mathbb{E}_{\mathbf{x} \sim q} \left[\frac{1}{p(\mathbf{x})} \frac{d}{d\mathbf{x}} [k_{\mathbf{v}}(\mathbf{x}) p(\mathbf{x})] \right].$$

Consider $p = \mathcal{N}(0, 1)$ and $q = \mathcal{N}(0, \sigma_q^2)$. Use unit-width Gaussian kernel.

$$g(v) = \frac{v \exp\left(-\frac{v^2}{2+2\sigma_q^2}\right) (\sigma_q^2 - 1)}{(1 + \sigma_q^2)^{3/2}}$$

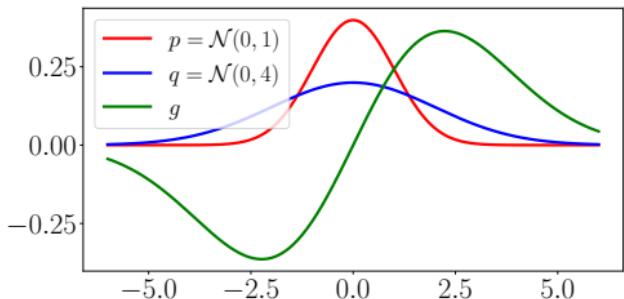
- If $v = 0$, then $\text{FSSD}^2 = g^2(v) = 0$ regardless of σ_q^2 .
- If $g \neq 0$, and k is real analytic, $R = \{v \mid g(v) = 0\}$ (blind spots) has 0 Lebesgue measure.
- So, if $v \sim$ a distribution with a density, then $v \notin R$.

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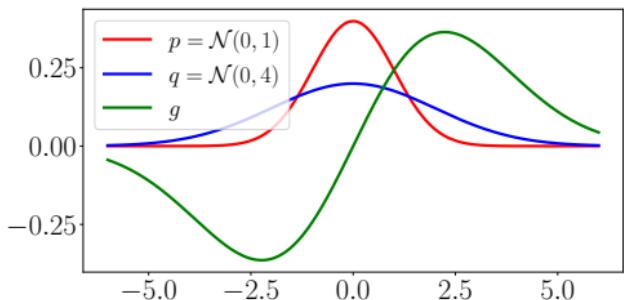
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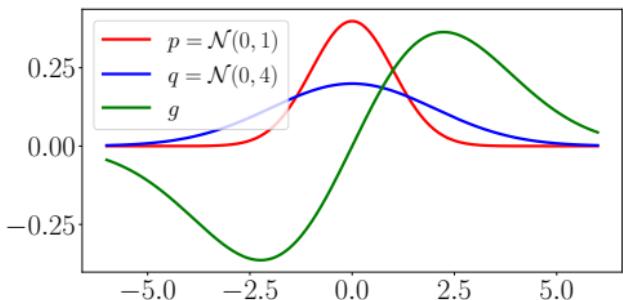
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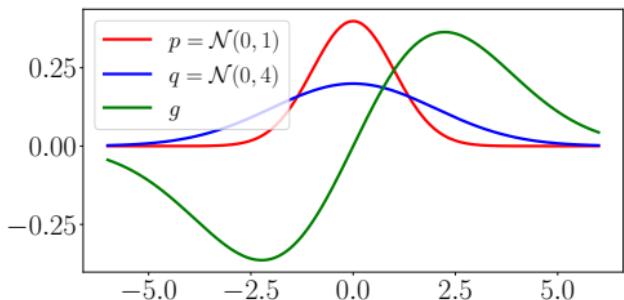
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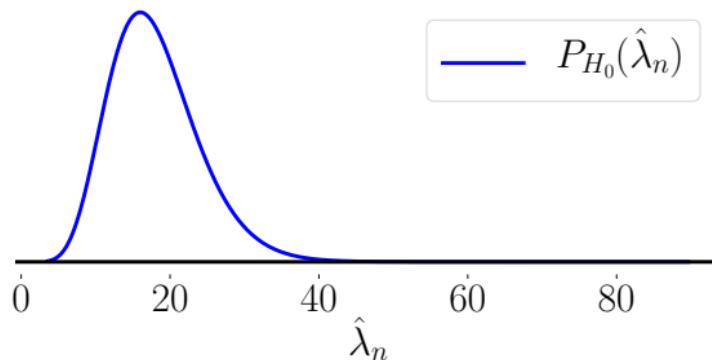
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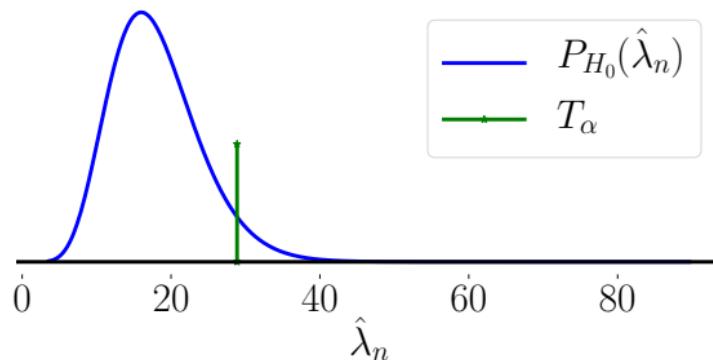


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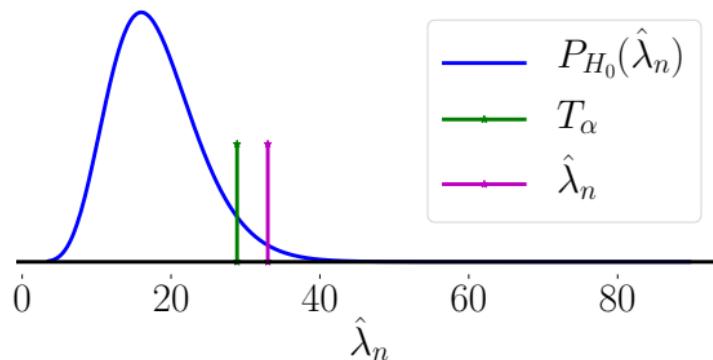
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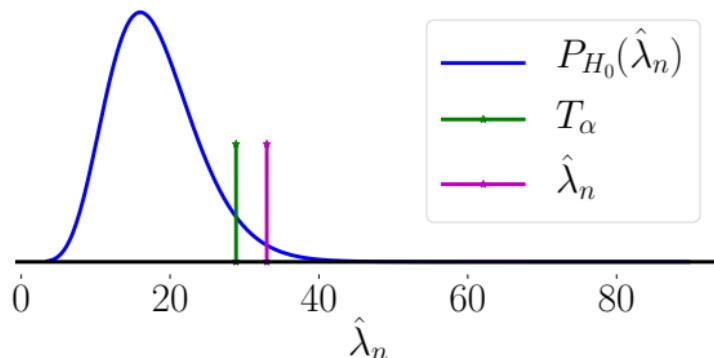
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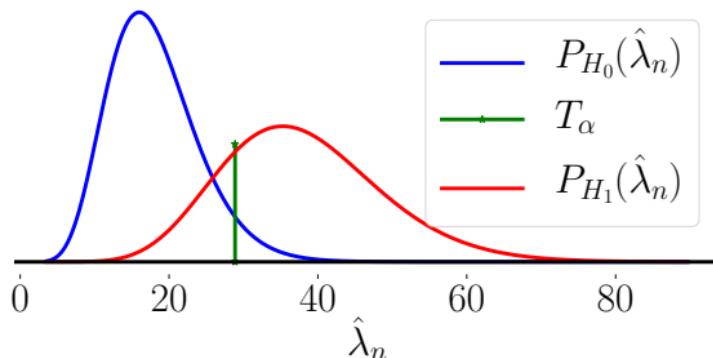


- Under $H_0 : p = q$, asymptotically

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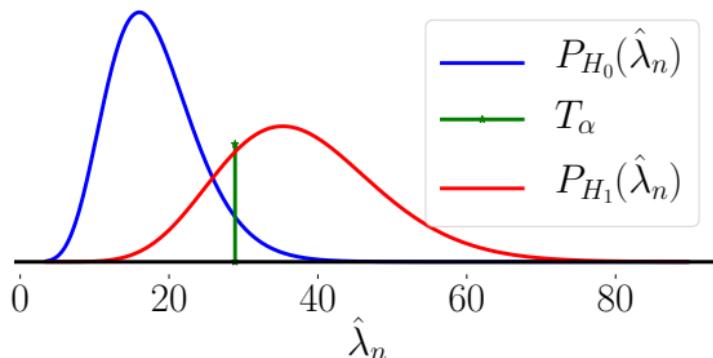
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witness²(V)

noise(V)

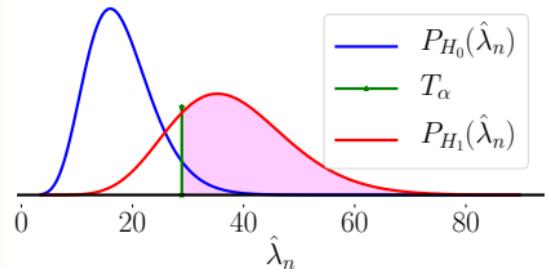
(4) What Does $\arg \max_v \text{score}(v)$ Do?

Proposition 1 (Asymptotic test power).

For large n , the test power $\mathbb{P}(\text{reject } H_0 \mid H_1 \text{ true}) =$

$$\begin{aligned}\mathbb{P}_{H_1}(n\widehat{\text{FSSD}}^2 > T_\alpha) \\ \approx \Phi \left(\sqrt{n} \frac{\text{FSSD}^2}{\sigma_{H_1}} - \frac{T_\alpha}{\sqrt{n}\sigma_{H_1}} \right),\end{aligned}$$

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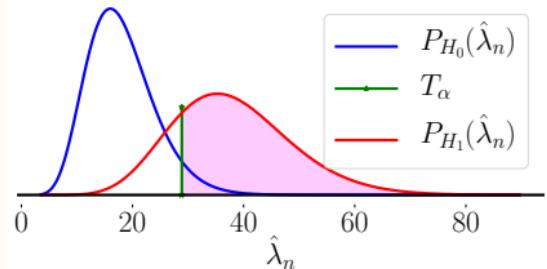
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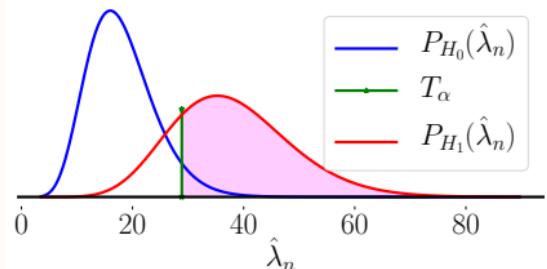
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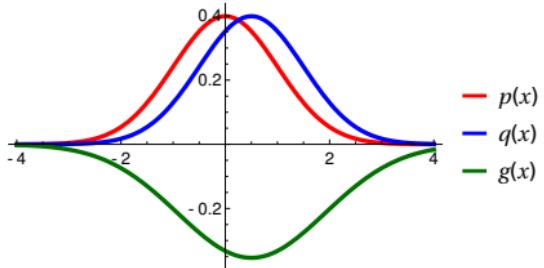
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Related Works

Kernel Stein Discrepancy (KSD) [Liu et al., 2016, Chwialkowski et al., 2016]

- Recall Stein witness:

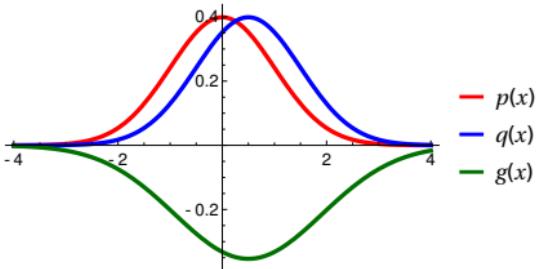
$$g(\mathbf{v}) := \mathbb{E}_{\mathbf{x} \sim q} \left[\frac{1}{p(x)} \frac{d}{dx} [k_{\mathbf{v}}(\mathbf{x}) p(\mathbf{x})] \right].$$



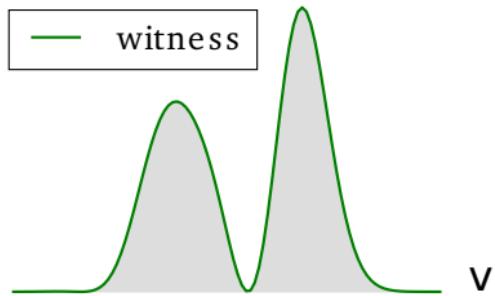
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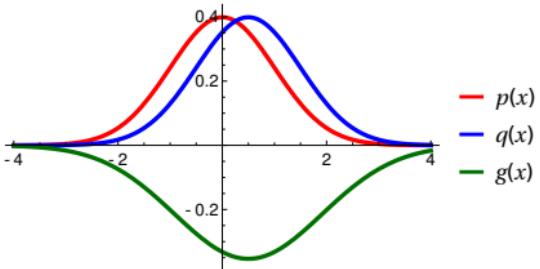
$$\text{KSD}^2 = \|g\|_{\text{RKHS}}^2 \text{ (RKHS norm).}$$

Good when the difference between
 p, q is spatially diffuse.

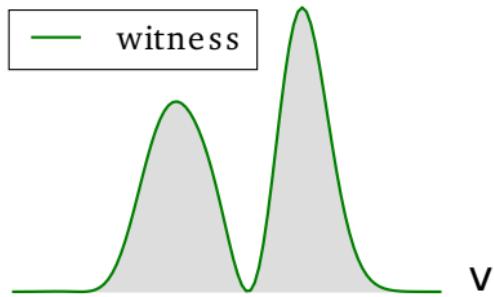
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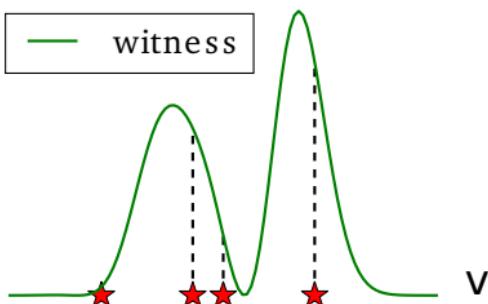
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Proposed FSSD



$$\text{FSSD}^2 = \frac{1}{dJ} \sum_{j=1}^J \|\mathbf{g}(v_j)\|_2^2.$$

Good when the difference between p, q is local.

Kernel Stein Discrepancy (KSD)

Closed-form expression for KSD: [Liu et al., 2016, Chwialkowski et al., 2016]

$$\text{KSD}^2 = \|\mathbf{g}\|_{\text{RKHS}}^2 = \overbrace{\mathbb{E}_{\mathbf{x} \sim \mathbf{q}} \mathbb{E}_{\mathbf{y} \sim \mathbf{q}}}^{\text{double sums}} h_{\mathbf{p}}(\mathbf{x}, \mathbf{y})$$

where

$$\begin{aligned} h_{\mathbf{p}}(\mathbf{x}, \mathbf{y}) &:= [\partial_{\mathbf{x}} \log \mathbf{p}(\mathbf{x})] k(\mathbf{x}, \mathbf{y}) [\partial_{\mathbf{y}} \log \mathbf{p}(\mathbf{y})] \\ &\quad + [\partial_{\mathbf{y}} \log \mathbf{p}(\mathbf{y})] \partial_{\mathbf{x}} k(\mathbf{x}, \mathbf{y}) \\ &\quad + [\partial_{\mathbf{x}} \log \mathbf{p}(\mathbf{x})] \partial_{\mathbf{y}} k(\mathbf{x}, \mathbf{y}) \\ &\quad + \partial_{\mathbf{x}} \partial_{\mathbf{y}} k(\mathbf{x}, \mathbf{y}) \end{aligned}$$

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Linear-Time Kernel Stein Discrepancy (LKS)

- [Liu et al., 2016] also proposed a linear version of KSD.
- For $\{\mathbf{x}_i\}_{i=1}^n \sim q$, KSD test statistic is

$$\frac{2}{n(n-1)} \sum_{i < j} h_p(\mathbf{x}_i, \mathbf{x}_j).$$

	1	2	3	4	5	6	7	8
1								
2								
3								
4								
5								
6								
7								
8								

- LKS test statistic is a “running average”

$$\frac{2}{n} \sum_{i=1}^{n/2} h_p(\mathbf{x}_{2i-1}, \mathbf{x}_{2i}).$$

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- Both unbiased. LKS has $\mathcal{O}(d^2 n)$ runtime. Same as proposed FSSD.
- X** LKS has high variance. Poor test power.

Simulation Settings

■ Gaussian kernel $k(\mathbf{x}, \mathbf{v}) = \exp\left(-\frac{\|\mathbf{x}-\mathbf{v}\|_2^2}{2\sigma_k^2}\right)$

Method	Description
1 FSSD-opt	Proposed. With optimization. $J = 5$.
2 FSSD-rand	Proposed. Random test locations.
3 KSD	Quadratic-time kernel Stein discrepancy [Liu et al., 2016, Chwialkowski et al., 2016]
4 LKS	Linear-time running average version of KSD.
5 MMD-opt	MMD two-sample test [Gretton et al., 2012]. With optimization.
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- Two-sample tests need to draw sample from p .
- Tests with optimization use 20% of the data.
- Significance level $\alpha = 0.05$.

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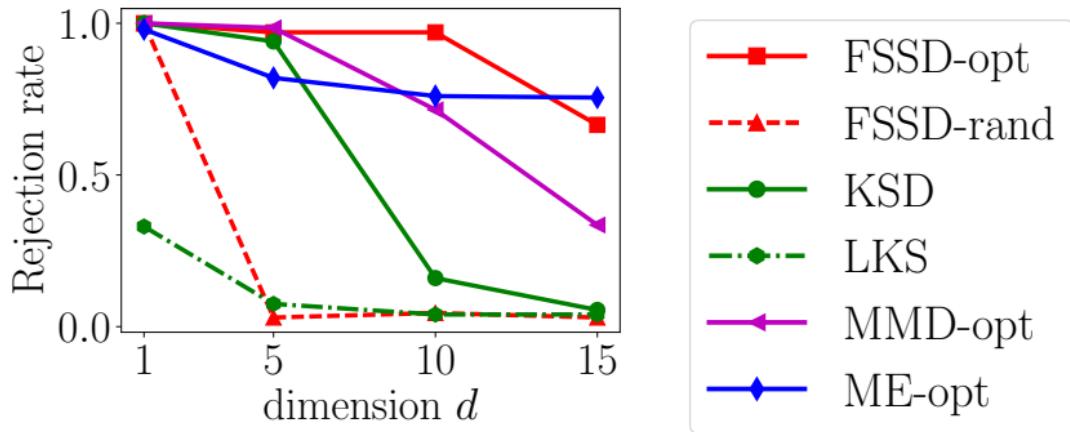
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Gaussian Vs. Laplace

- $p = \text{Gaussian}$. $q = \text{Laplace}$. Same mean and variance. High-order moments differ.
- Sample size $n = 1000$.



- Optimization increases the power.
- Two-sample tests can perform well in this case (p, q clearly differ).

Gaussian-Bernoulli Restricted Boltzmann Machine (RBM)

- $p(\mathbf{x})$ is the marginal of

$$p(\mathbf{x}, \mathbf{h}) = \frac{1}{Z} \exp \left(\mathbf{x}^\top \mathbf{B} \mathbf{h} + \mathbf{b}^\top \mathbf{x} + \mathbf{c}^\top \mathbf{x} - \frac{1}{2} \|\mathbf{x}\|^2 \right),$$

where $\mathbf{x} \in \mathbb{R}^{50}$, $\mathbf{h} \in \{\pm 1\}^{40}$ is latent. Randomly pick $\mathbf{B}, \mathbf{b}, \mathbf{c}$.

- $q(\mathbf{x}) = p(\mathbf{x})$ with i.i.d. $\mathcal{N}(0, \sigma_{per})$ noise added to all entries of \mathbf{B} .
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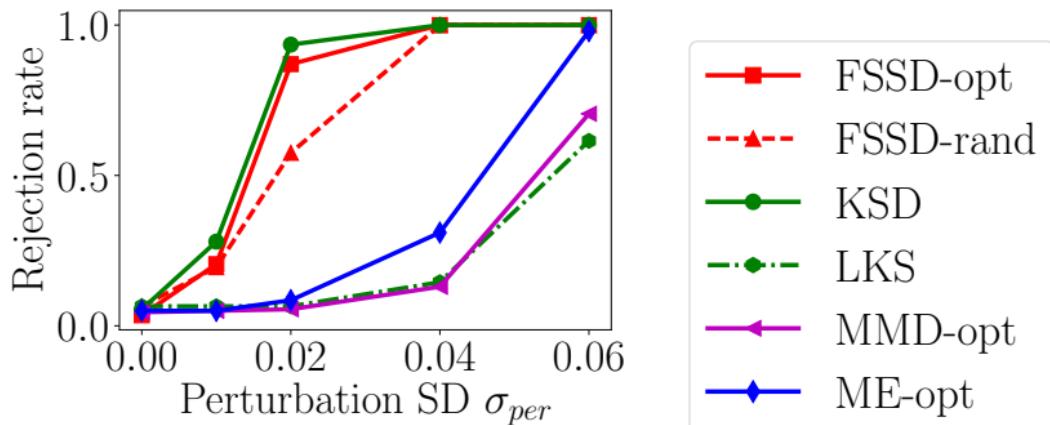
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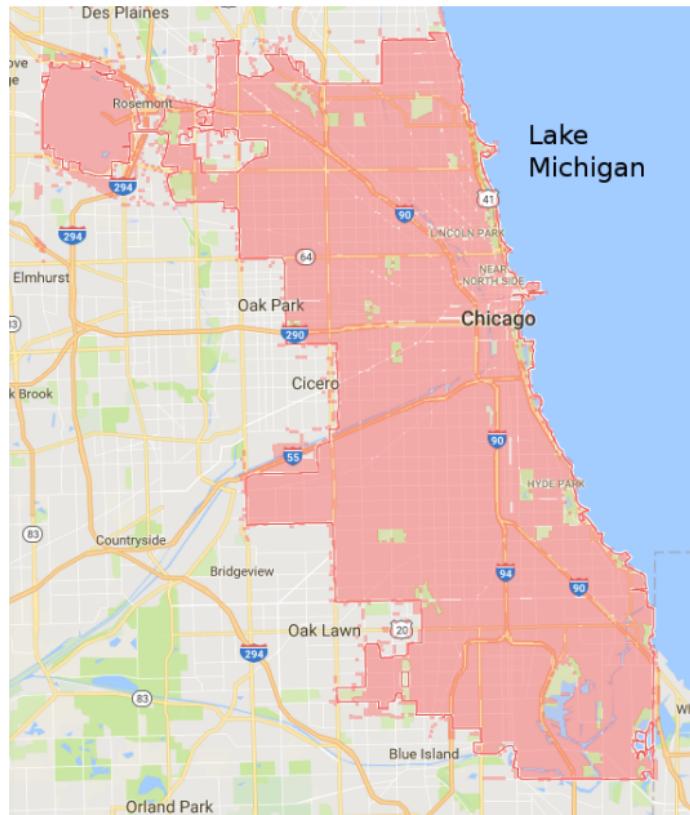
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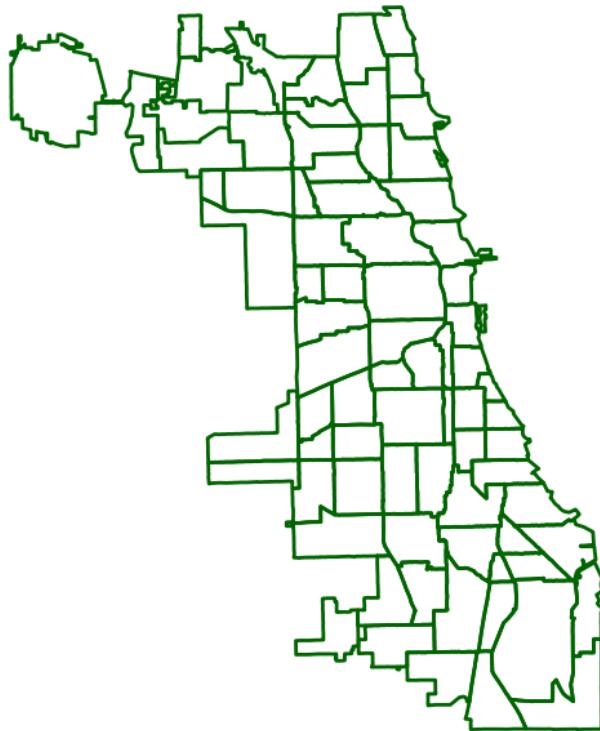


KSD ($\mathcal{O}(n^2)$), FSSD-opt ($\mathcal{O}(n)$) comparable. LKS has low power.

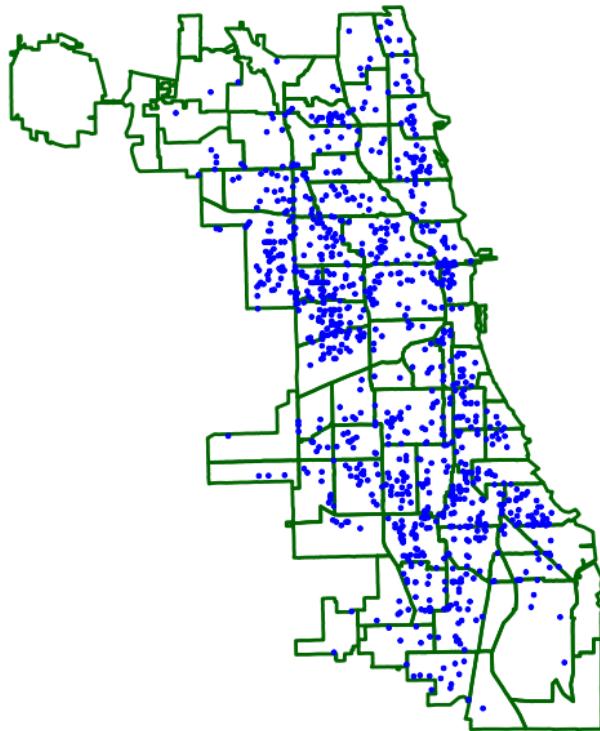
Interpretable Test Locations: Chicago Crime



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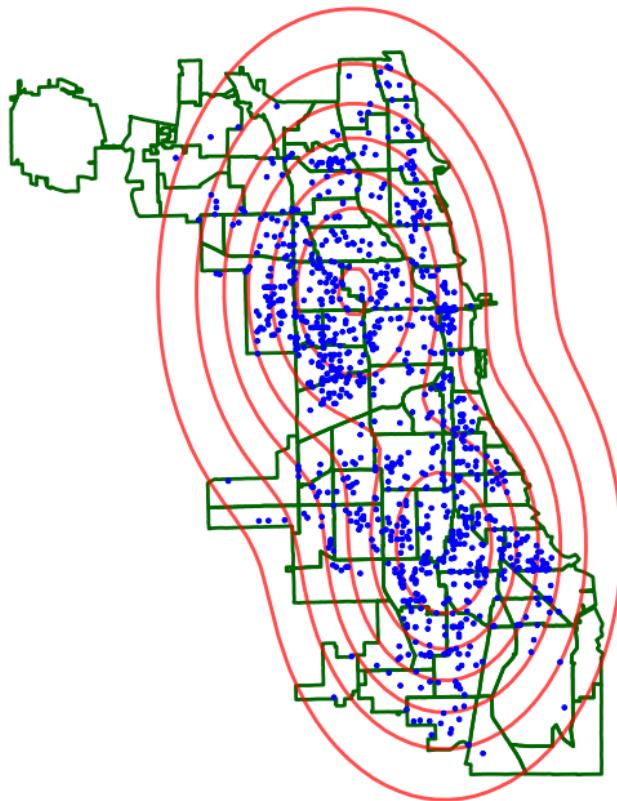


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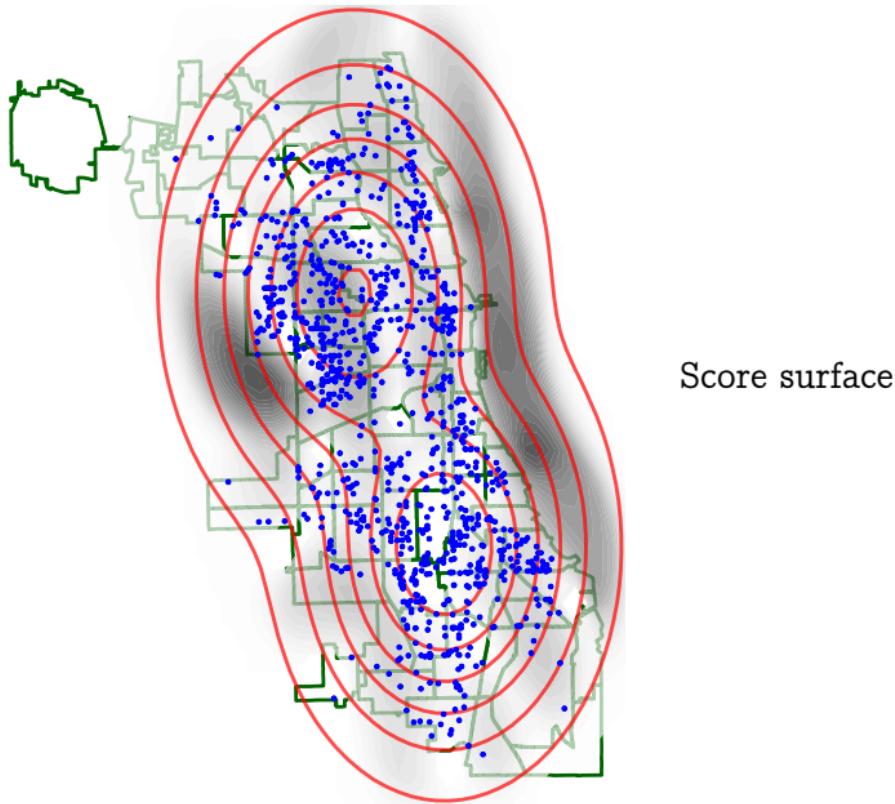
- $n = 11957$ robbery events in Chicago in 2016.
 - lat/long coordinates = sample from q .
- Model spatial density with Gaussian mixtures.

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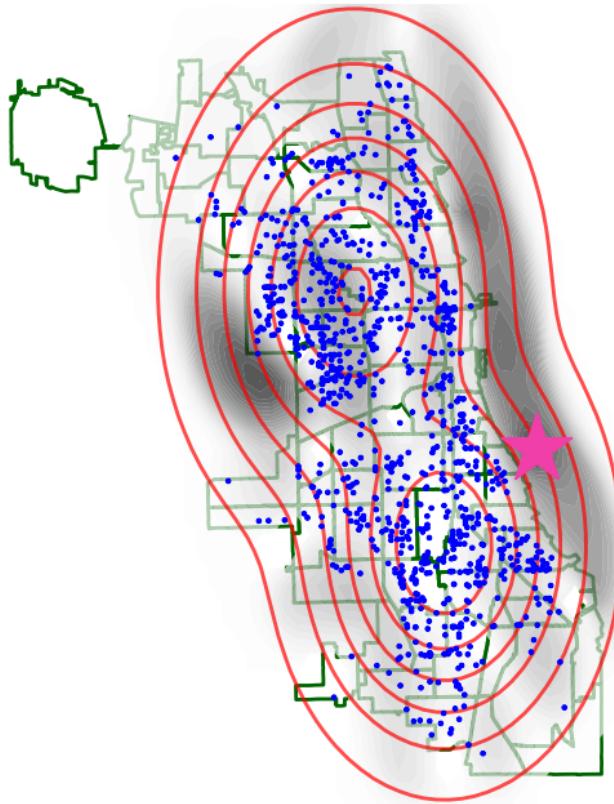
Model p = 2-component Gaussian mixture.

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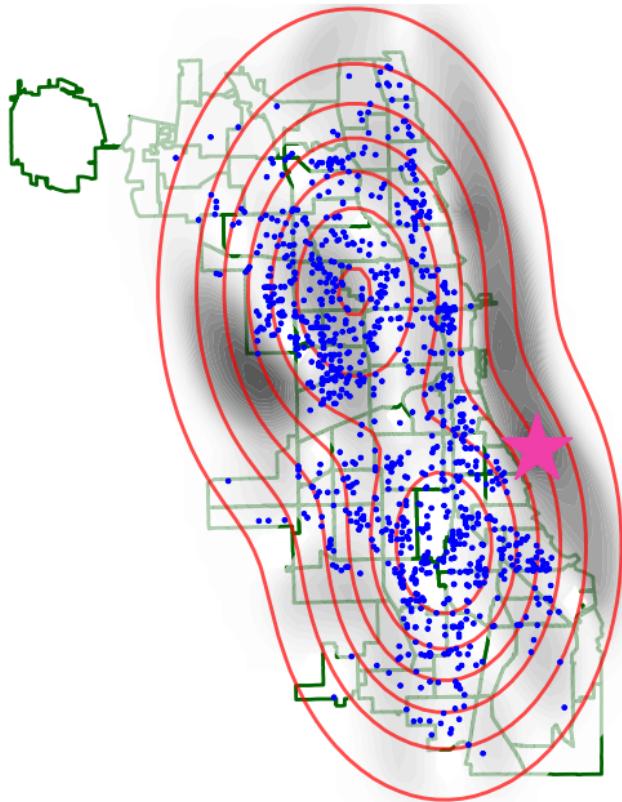
Score surface

Interpretable Test Locations: Chicago Crime



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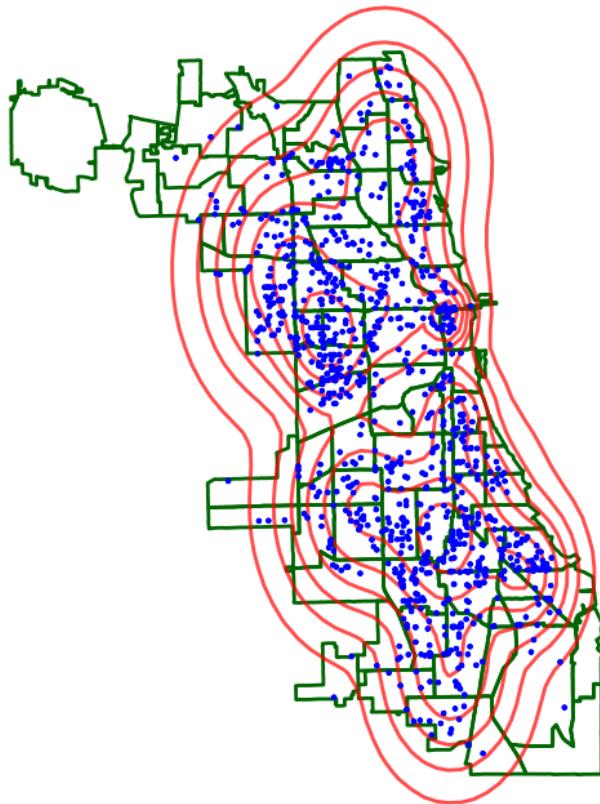
Interpretable Test Locations: Chicago Crime



★ = optimized v.
No robbery in Lake Michigan.

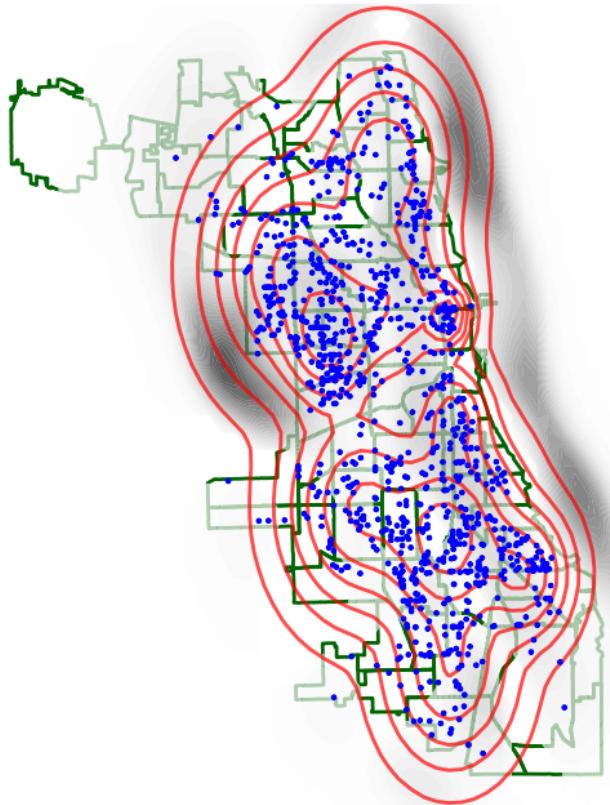


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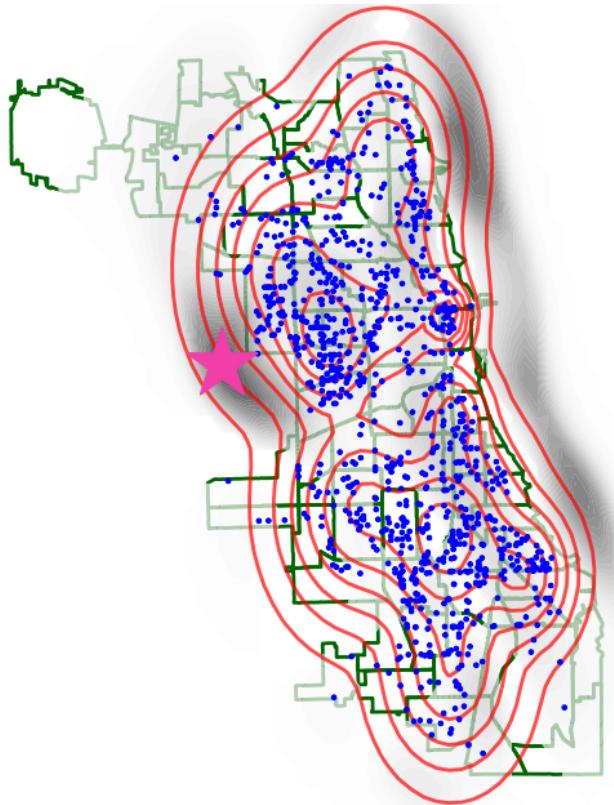
Model p = 10-component Gaussian mixture.

Interpretable Test Locations: Chicago Crime



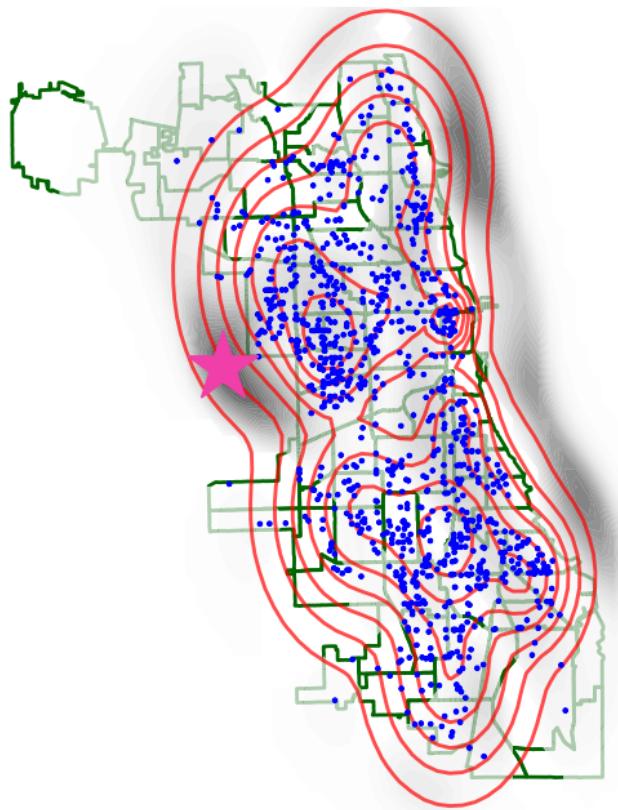
Capture the right tail better.

Interpretable Test Locations: Chicago Crime



Still, does not capture the left tail.

Interpretable Test Locations: Chicago Crime



Still, does not capture the left tail.

Learned test locations are interpretable.

Bahadur Slope and Bahadur Efficiency

- Bahadur slope \approx rate of p-value $\rightarrow 0$ under H_1 as $n \rightarrow \infty$.
- Measure a test's sensitivity to the departure from H_0 .

$$H_0: \theta = 0,$$

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- Typically $\text{pval}_n \approx \exp\left(-\frac{1}{2}c(\theta)n\right)$ where $c(\theta) > 0$ under H_1 , and $c(0) = 0$ [Bahadur, 1960].
- $c(\theta)$ higher \implies more sensitive. Good.

Bahadur slope

$$c(\theta) := -2 \operatorname{plim}_{n \rightarrow \infty} \frac{\log(1 - F(T_n))}{n},$$

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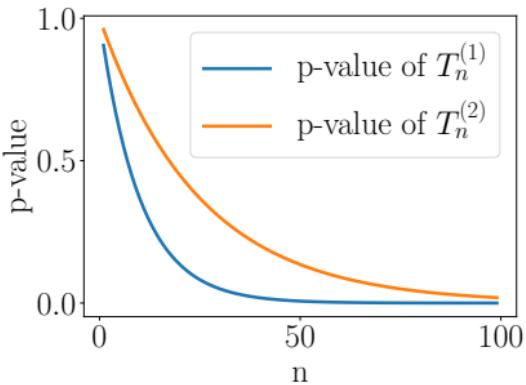
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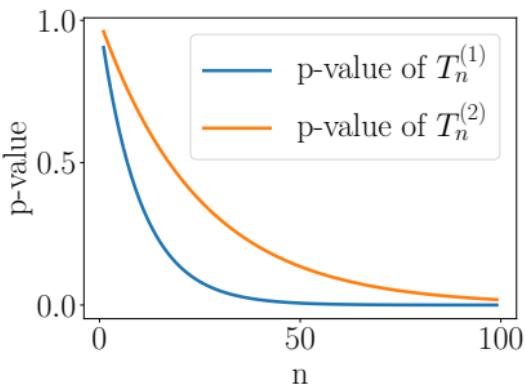
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Gaussian Mean Shift Problem

Consider $p = \mathcal{N}(0, 1)$ and $q = \mathcal{N}(\mu_q, 1)$.

■ Assume $J = 1$ location for $\widehat{nFSSD^2}$. Gaussian kernel (bandwidth = σ_k^2)

$$c^{(FSSD)}(\mu_q, v, \sigma_k^2) = \frac{\sigma_k^2 (\sigma_k^2 + 2)^3 \mu_q^2 e^{\frac{v^2}{\sigma_k^2+2} - \frac{(v-\mu_q)^2}{\sigma_k^2+1}}}{\sqrt{\frac{2}{\sigma_k^2} + 1} (\sigma_k^2 + 1) (\sigma_k^6 + 4\sigma_k^4 + (v^2 + 5)\sigma_k^2 + 2)}.$$

■ For LKS, Gaussian kernel (bandwidth = κ^2).

$$c^{(LKS)}(\mu_q, \kappa^2) = \frac{(\kappa^2)^{5/2} (\kappa^2 + 4)^{5/2} \mu_q^4}{2(\kappa^2 + 2)(\kappa^8 + 8\kappa^6 + 21\kappa^4 + 20\kappa^2 + 12)}.$$

Theorem 2 (FSSD is at least two times more efficient).

Fix $\sigma_k^2 = 1$ for $\widehat{nFSSD^2}$. Then, $\forall \mu_q \neq 0$, $\exists v \in \mathbb{R}$, $\forall \kappa^2 > 0$, we have Bahadur efficiency

$$\frac{c^{(FSSD)}(\mu_q, v, \sigma_k^2)}{c^{(LKS)}(\mu_q, \kappa^2)} > 2.$$

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Fix $\sigma_k^2 = 1$ for $n\widehat{\text{FSSD}}^2$. Then, $\forall \mu_q \neq 0$, $\exists v \in \mathbb{R}$, $\forall \kappa^2 > 0$, we have Bahadur efficiency

$$\frac{c^{(\text{FSSD})}(\mu_q, v, \sigma_k^2)}{c^{(\text{LKS})}(\mu_q, \kappa^2)} > 2.$$

Gaussian Mean Shift Problem

Consider $p = \mathcal{N}(0, 1)$ and $q = \mathcal{N}(\mu_q, 1)$.

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Conclusion

- Proposed **The Finite Set Stein Discrepancy (FSSD)**.
- Goodness-of-fit test based on FSSD is
 - 1 nonparametric,
 - 2 linear-time,
 - 3 tunable (parameters automatically tuned).
 - 4 interpretable.

A Linear-Time Kernel Goodness-of-Fit Test

Wittawat Jitkrittum, Wenkai Xu, Zoltán Szabó, Kenji Fukumizu, Arthur Gretton

NIPS 2017 (best paper award)

Python code: <https://github.com/wittawatj/kgof>

Questions?

Thank you

Illustration: Score Surface

- Consider $J = 1$ location.
- $\text{score}(\mathbf{v}) = \frac{\widehat{\text{FSSD}}^2(\mathbf{v})}{\widehat{\sigma}_{H_1}(\mathbf{v})}$ (gray), p in wireframe, $\{\mathbf{x}_i\}_{i=1}^n \sim q$ in purple, \star = best \mathbf{v} .

$$p = \mathcal{N}\left(\mathbf{0}, \begin{pmatrix} 1 & 0 \\ 0 & 1 \end{pmatrix}\right) \text{ vs. } q = \mathcal{N}\left(\mathbf{0}, \begin{pmatrix} 2 & 0 \\ 0 & 1 \end{pmatrix}\right).$$

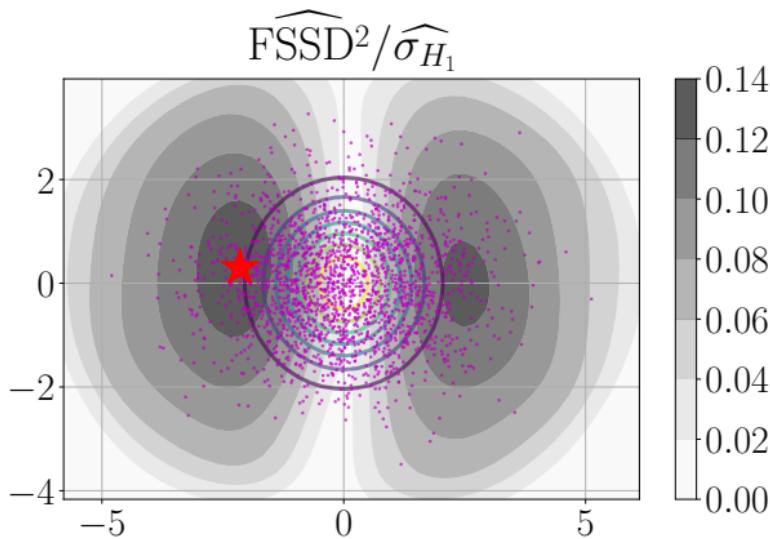
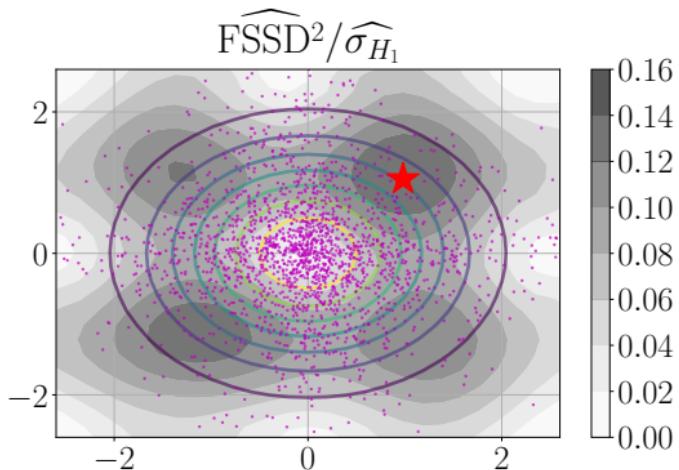
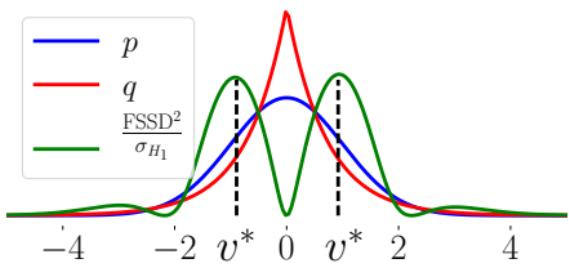


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$p = \mathcal{N}(\mathbf{0}, \mathbf{I})$ vs. $q = \text{Laplace}$ with same mean & variance.



FSSD and KSD in 1D Gaussian Case

Consider $p = \mathcal{N}(0, 1)$ and $q = \mathcal{N}(\mu_q, \sigma_q^2)$.

- Assume $J = 1$ feature for $n\widehat{\text{FSSD}}^2$. Gaussian kernel (bandwidth = σ_k^2).

$$\text{FSSD}^2 = \frac{\sigma_k^2 e^{-\frac{(\nu - \mu_q)^2}{\sigma_k^2 + \sigma_q^2}} ((\sigma_k^2 + 1) \mu_q + \nu (\sigma_q^2 - 1))^2}{(\sigma_k^2 + \sigma_q^2)^3}.$$

- If $\mu_q \neq 0, \sigma_q^2 \neq 1$, and $\nu = -\frac{(\sigma_k^2 + 1)\mu_q}{(\sigma_q^2 - 1)}$, then $\text{FSSD}^2 = 0$!
 - This is why ν should be drawn from a distribution with a density.
- For KSD, Gaussian kernel (bandwidth = κ^2).

$$S^2 = \frac{\mu_q^2 (\kappa^2 + 2\sigma_q^2) + (\sigma_q^2 - 1)^2}{(\kappa^2 + 2\sigma_q^2) \sqrt{\frac{2\sigma_q^2}{\kappa^2} + 1}}.$$

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FSSD is a Discrepancy Measure

Theorem 3.

Let $V = \{v_1, \dots, v_J\} \subset \mathbb{R}^d$ be drawn i.i.d. from a distribution η which has a density. Let \mathcal{X} be a connected open set in \mathbb{R}^d . Assume

- 1 (*Nice RKHS*) Kernel $k: \mathcal{X} \times \mathcal{X} \rightarrow \mathbb{R}$ is C_0 -universal, and real analytic.
- 2 (*Stein witness not too rough*) $\|g\|_{\mathcal{F}}^2 < \infty$.
- 3 (*Finite Fisher divergence*) $\mathbb{E}_{x \sim q} \|\nabla_x \log \frac{p(x)}{q(x)}\|^2 < \infty$.
- 4 (*Vanishing boundary*) $\lim_{\|x\| \rightarrow \infty} p(x)g(x) = 0$.

Then, for any $J \geq 1$, η -almost surely

$$\text{FSSD}^2 = 0 \text{ if and only if } p = q.$$

- Gaussian kernel $k(x, v) = \exp\left(-\frac{\|x-v\|_2^2}{2\sigma_k^2}\right)$ works.
- In practice, $J = 1$ or $J = 5$.

Asymptotic Distributions of $\widehat{\text{FSSD}}^2$

- Recall $\xi(\mathbf{x}, \mathbf{v}) := \frac{1}{\mathbf{p}(\mathbf{x})} \partial_{\mathbf{x}}[k(\mathbf{x}, \mathbf{v}) \mathbf{p}(\mathbf{x})] \in \mathbb{R}^d$.
- $\tau(\mathbf{x}) :=$ vertically stack $\xi(\mathbf{x}, \mathbf{v}_1), \dots, \xi(\mathbf{x}, \mathbf{v}_J) \in \mathbb{R}^{dJ}$. Feature vector of \mathbf{x} .
- Mean feature: $\mu := \mathbb{E}_{\mathbf{x} \sim q}[\tau(\mathbf{x})]$.
- $\Sigma_r := \text{cov}_{\mathbf{x} \sim r}[\tau(\mathbf{x})] \in \mathbb{R}^{dJ \times dJ}$ for $r \in \{p, q\}$

Proposition 2 (Asymptotic distributions).

Let $Z_1, \dots, Z_{dJ} \stackrel{i.i.d.}{\sim} \mathcal{N}(0, 1)$, and $\{\omega_i\}_{i=1}^{dJ}$ be the eigenvalues of Σ_p .

- 1 Under $H_0 : p = q$, asymptotically $n\widehat{\text{FSSD}}^2 \xrightarrow{d} \sum_{i=1}^{dJ} (Z_i^2 - 1)\omega_i$.
 - Easy to simulate to get p -value.
 - Simulation cost independent of n .
- 2 Under $H_1 : p \neq q$, we have $\sqrt{n}(\widehat{\text{FSSD}}^2 - \text{FSSD}^2) \xrightarrow{d} \mathcal{N}(0, \sigma_{H_1}^2)$ where $\sigma_{H_1}^2 := 4\mu^\top \Sigma_q \mu$. Implies $\mathbb{P}(\text{reject } H_0) \rightarrow 1$ as $n \rightarrow \infty$.

But, how to estimate Σ_p ? No sample from \mathbf{p} !

- Theorem: Using $\hat{\Sigma}_q$ (computed with $\{\mathbf{x}_i\}_{i=1}^n \sim q$) still leads to a consistent test.

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Bahadur Slopes of FSSD and LKS

Theorem 4.

The Bahadur slope of $n\widehat{\text{FSSD}}^2$ is

$$c^{(\text{FSSD})} := \text{FSSD}^2 / \omega_1,$$

where ω_1 is the maximum eigenvalue of $\Sigma_p := \text{cov}_{\mathbf{x} \sim p}[\tau(\mathbf{x})]$.

Theorem 5.

The Bahadur slope of the linear-time kernel Stein (LKS) statistic $\sqrt{n}\widehat{S}_l^2$ is

$$c^{(\text{LKS})} = \frac{1}{2} \frac{\left[\mathbb{E}_q h_p(\mathbf{x}, \mathbf{x}') \right]^2}{\mathbb{E}_p [h_p^2(\mathbf{x}, \mathbf{x}')]},$$

where h_p is the U-statistic kernel of the KSD statistic.

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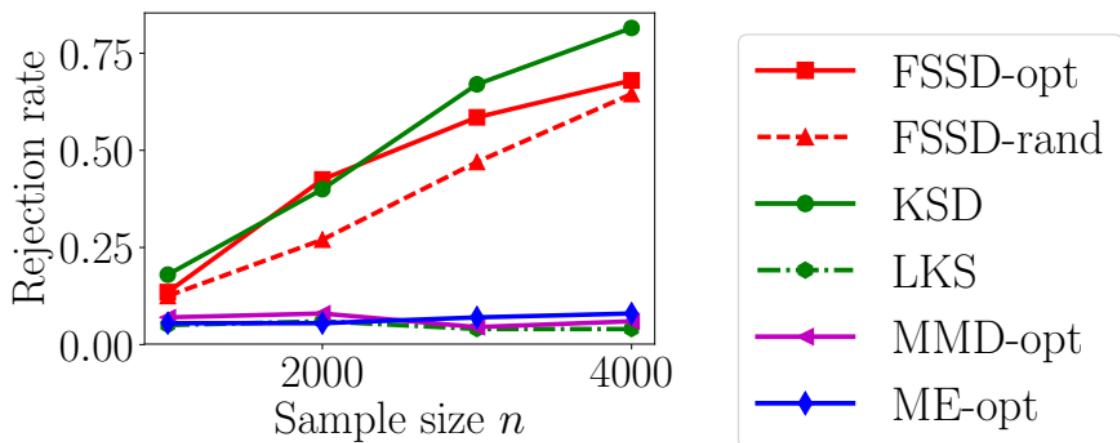
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Harder RBM Problem

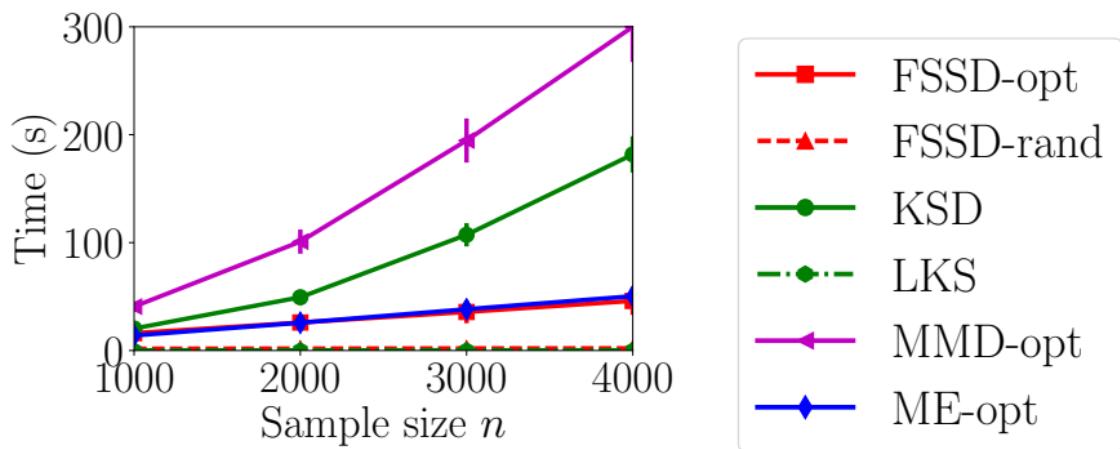
- Perturb only one entry of $\mathbf{B} \in \mathbb{R}^{50 \times 40}$ (in the RBM).
- $B_{1,1} \leftarrow B_{1,1} + \mathcal{N}(0, \sigma_{per}^2 = 0.1^2)$.



- Two-sample tests fail. Samples from p, q look roughly the same.
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